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HEARING AID COMPATIBILITY

Applicant Name:
Samsung Electronics Co., Ltd.
129, Samsung-ro, Maetan dong,
Yeongtong-gu, Suwon-si
Gyeonggi-do 16677, Korea

Date of Testing:
9/26/2022 - 11/3/2022
Test Site/Location:
Element Washington DC LLC,
Columbia, MD, USA
Test Report Serial No.:
1M2209010098-25-R1.A3L
Date of Issue:
11/15/2022

FCC ID:	**A3LSMS918U**
APPLICANT:	**SAMSUNG ELECTRONICS CO., LTD.**

Scope of Test:	RF Emissions Testing
Application Type:	Certification
FCC Rule Part(s):	CFR §20.19(b)
HAC Standard:	ANSI C63.19-2011 285076 D01 HAC Guidance v06r02 285076 D02 T-Coil testing for CMRS IP v04
DUT Type:	Portable Handset
Model:	SM-S918U
Additional Model(s):	SM-S918U1
Test Device Serial No.:	*Pre-Production Sample* [S/N: 1518M, 0215M]

C63.19-2011 HAC Category:	**M3 (RF EMISSIONS CATEGORY)**

Note: This revised Test Report (S/N: 1M2209010098-25-R1.A3L) supersedes and replaces the previously issued test report on the same subject device for the same type of testing as indicated. Please discard or destroy the previously issued test report(s) and dispose of it accordingly.

This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. Test results reported herein relate only to the item(s) tested. North America bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.

RJ Ortanez
Executive Vice President

ilac-MRA
ACCREDITED
CERT #2041.01

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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658[1] to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.

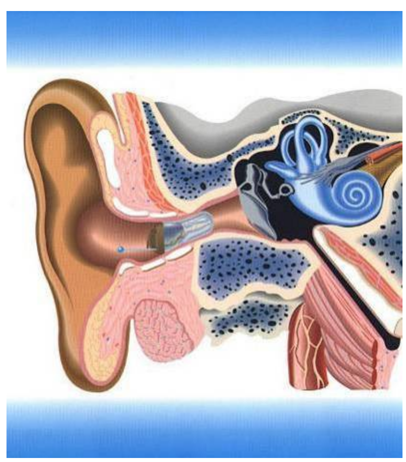


Figure 1-1 Hearing Aid *in-vitu*

[1] FCC Rule & Order, WT Docket 01-309 RM-8658

2. DUT DESCRIPTION

FCC ID:	A3LSMS918U
Manufacturer:	Samsung Electronics Co., Ltd. 129, Samsung-ro, Maetan dong, Yeongtong-gu, Suwon-si Gyeonggi-do 16677, Korea
Model:	SM-S918U
Additional Model(s):	SM-S918U1
Serial Number:	1518M, 0215M
Antenna Configurations:	Internal Antenna
DUT Type:	Portable Handset

I. LTE Band Selection

This device supports LTE capabilities with overlapping transmission frequency ranges. When the supported frequency range of an LTE band falls completely within an LTE band with a larger transmission frequency range, both LTE bands have the same target power (or the band with the larger transmission frequency range has a higher target power), and both LTE bands share the same transmission path and signal characteristics, hearing-aid compatibility compliance was only assessed for the band with the larger transmission frequency range. However, overlapped LTE bands which are anchor bands for dual connectivity (EN-DC) scenarios between LTE and NR were evaluated as independent LTE bands.

II. NR Band Selection

This device supports NR capabilities with overlapping transmission frequency ranges. When the supported frequency range of an NR band falls completely within an NR band with a larger transmission frequency range, both NR bands have the same target power (or the band with the larger transmission frequency range has a higher target power), and both NR bands share the same transmission path and signal characteristics, hearing-aid compatibility compliance was only assessed for the band with the larger transmission frequency range.

III. Device Serial Numbers

Several samples with identical hardware were used to support HAC testing. The manufacturer has confirmed that the device(s) tested have the same physical, mechanical, and thermal characteristics are within operational tolerances expected for production units. The serial numbers used for each test are indicated alongside the results in Section 11.

Table 2-1
A3LSMS918U HAC Air Interfaces

Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Name of Voice Service
GSM	850	VO	Yes	Yes: WIFI or BT	CMRS Voice
	1900				
	GPRS/EDGE	VD	No[1]	Yes: WIFI or BT	Google Meet
UMTS	850	VD	No[1]	Yes: WIFI or BT	CMRS Voice
	1700				
	1900				
	HSPA	VD	No[1]	Yes: WIFI or BT	Google Meet
LTE (FDD)	680 (B71)	VD	No[1,2]	Yes: NR, WIFI or BT	VoLTE, Google Meet
	700 (B12)		No[1]		
	780 (B13)				
	790 (B14)				
	850 (B5)				
	850 (B26)				
	1700 (B4)				
	1700 (B66)				
	1900 (B2)				
	1900 (B25)				
	2300 (B30)				
	2500 (B7)				
LTE (TDD)	2600 (B38)	VD	Yes	Yes: NR, WIFI or BT	VoLTE, Google Meet
	2600 (B41)				
	3600 (B48)				
NR (FDD)	680 (n71)	VD	No[1,2]	Yes: LTE, WIFI or BT	VoNR, Google Meet
	700 (n12)		No[1]		
	850 (n5)				
	850 (n26)				
	1700 (n66)				
	1900 (n2)				
	1900 (n25)				
	2300 (n30)				
	2500 (n7)				
NR (TDD)	2600 (n38)	VD	Yes	Yes: LTE, WIFI or BT	VoNR, Google Meet
	2600 (n41)				
	3500 (n77, DoD)				
	3600 (n48)				
	3700 (n77)				
	26000 (n258)		No[3]		
	28000 (n261)				
	39000 (n260)				
WIFI	2450	VD	No[1]	Yes: GSM, UMTS, LTE, or NR	VoWIFI, Google Meet
	5200 (U-NII 1)				
	5300 (U-NII 2A)				
	5500 (U-NII 2C)				
	5800 (U-NII 3)				
	5900 (U-NII 4)				
	6175 (U-NII 5)		No[1,4]		
	6475 (U-NII 6)		No[5]		
	6700 (U-NII 7)				
	7000 (U-NII 8)				
BT	2450	DT	No	Yes: GSM, UMTS, LTE, or NR	N/A

Type Transport
VO = Voice Only
DT = Digital Data - Not intended for Voice Services
VD = CMRS and/or IP Voice over Data Transport

Notes:
1. Evaluated for MIF and low-power exemption.
2. LTE B71 and NR n71, while outside the scope of ANSI C63.19 and FCC HAC regulations, were additionally tested according to the existing HAC procedures with currently available test equipment.
3. NR FR2 bands are currently outside the scope of ANSI C63.19 and FCC HAC regulations therefore they were not evaluated.
4. WIFI U-NII band 5 was evaluated for operations which are entirely below 6 GHz. Operations partially or entirely above 6 GHz were not evaluated due to equipment liminations and being outside of the current scope of ANSI C63.19 and FCC HAC regulations.
5. WIFI U-NII bands 6 through 8 were not evaluated due to equipment limitations and being outside of the current scope of ANSI C63.19 and FCC HAC regulations.

3. ANSI/IEEE C63.19 PERFORMANCE CATEGORIES

I. RF EMISSIONS

The ANSI Standard presents performance requirements for acceptable interoperability of hearing aids with wireless communications devices. When these parameters are met, a hearing aid operates acceptably in close proximity to a wireless communications device.

Category	Telephone RF Parameters
Near field Category	**E-field emissions CW dB(V/m)**
f < 960 MHz	
M1	50 to 55
M2	45 to 50
M3	40 to 45
M4	< 40
f > 960 MHz	
M1	40 to 45
M2	35 to 40
M3	30 to 35
M4	< 30

Table 3-1
WD near-field categories as defined in ANSI C63.19-2011

4. SYSTEM SPECIFICATIONS

EF3DV3 E-Field Probe Description

Construction:	One dipole parallel, two dipoles normal to probe axis Built-in shielding against static charges
Calibration:	In air from 30 MHz to 6.0 GHz (absolute accuracy ±5.1%, k=2)
Frequency:	30 MHz to > 6 GHz; Linearity: ± 0.2 dB (30 MHz to 6 GHz)
Directivity	± 0.2 dB in air (rotation around probe axis) ± 0.4 dB in air (rotation normal to probe axis)
Dynamic Range	2 V/m to > 1000 V/m (M3 or better device readings fall well below diode compression point)
Linearity:	± 0.2 dB
Dimensions	Overall length: 337 mm (Tip: 20 mm) Tip diameter: 4.0 mm (Body: 12 mm) Distance from probe tip to dipole centers: 1.5 mm

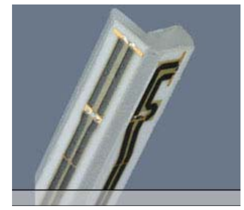
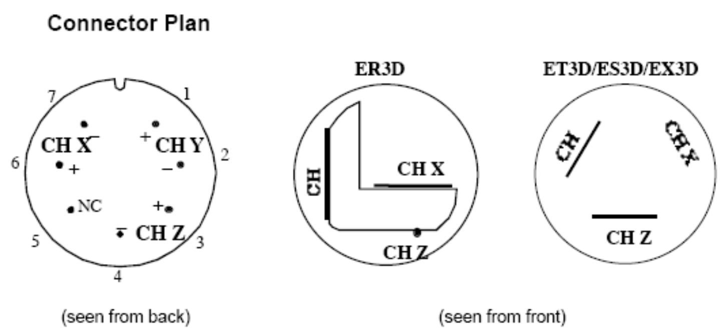


Figure 4-1
E-field Free-space Probe

Probe Tip Description

HAC field measurements take place in the close near field with high gradients. Increasing the measuring distance from the source will generally decrease the measured field values (in case of the validation dipole approx. 10% per mm).

The electric field probes have an irregular internal geometry because it is physically not possible to have the 3 orthogonal sensors situated with the same center. The effect of the different sensor centers is accounted for in the HAC uncertainty budget ("sensor displacement").



The antistatic shielding inside the probe is connected to the probe connector case.

Instrumentation Chain

Equation 1

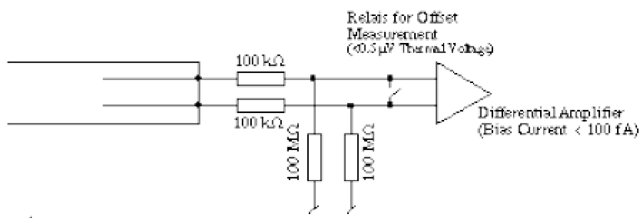
Conversion of Connector Voltage u_i to E-Field E_i

$$E_i = \sqrt{\frac{u_i + (u_i^2 \cdot CF)/(DCP)}{Norm_i \cdot ConvF}}$$

whereby

E_i:	electric field in V/m
u_i:	voltage of channel i at the connector in µV
$Norm_i$:	sensitivity of channel i in µV/(V/m)^2
ConvF:	enhancement factor in liquid (ConvF=1 for Air)
DCP:	diode compression point in µV
CF:	signal crest factor (peak power/average power)

Conditions of Calibration



Please note:

- a lower input impedance of the amplifier will result in different sensitivity factors *$Norm_i$* and *DCP*
- larger bias currents will cause higher offset

Probe Response to Frequency

The E-field sensors have inherently a very flat frequency response. They are calibrated with a number of frequencies resulting in a common calibration factor, with the frequency behavior documented in the calibration certificate (See also below).

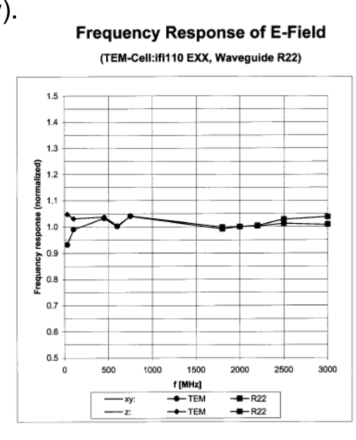


Figure 4-2 E-Field Probe Frequency Response

SPEAG Robotic System

E-field measurements are performed using the DASY5 automated dosimetric assessment system. The DASY5 is made by Schmid & Partner Engineering AG (SPEAG) in Zurich, Switzerland and consists of high precision robotics system (Staubli), robot controller, Intel CORE i7 computer, near-field probe, probe alignment sensor, and the HAC phantom. The robot is a six-axis industrial robot performing precise movements to position the probe to the location (points) of maximum electromagnetic field (EMF).

Figure 4-3
SPEAG Robotic System

System Hardware

A cell controller system contains the power supply, robot controller, teach pendant (Joystick), and a remote control used to drive the robot motors. The PC consists of the computer with operating system and RF Measurement Software DASY5 v52.8 (with HAC Extension), A/D interface card, monitor, mouse, and keyboard. The Staubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit that performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.

System Electronics

The DAE consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

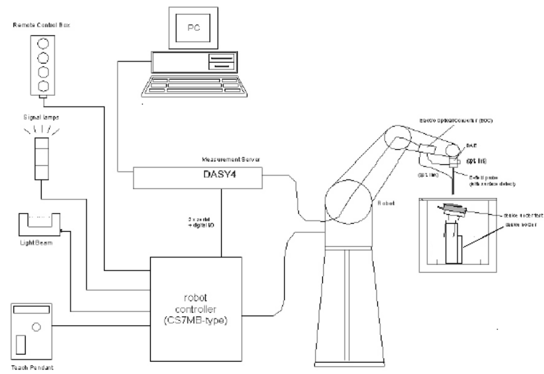


Figure 4-4
SPEAG Robotic System Diagram

DASY5 Instrumentation Chain

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp_i}$$

with	V_i	= compensated signal of channel i	(i = x, y, z)
	U_i	= input signal of channel i	(i = x, y, z)
	cf	= crest factor of exciting field	(DASY parameter)
	dcp_i	= diode compression point	(DASY parameter)

From the compensated input signals the primary field data for each channel can be evaluated:

$$\mathrm{E-fieldprobes:} \qquad E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

with V_i = compensated signal of channel i (i = x, y, z)
$Norm_i$ = sensor sensitivity of channel i (i = x, y, z)
$\mu V/(V/m)^2$ for E-field Probes
$ConvF$ = sensitivity enhancement in solution
E_i = electric field strength of channel i in V/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

The measurement/integration time per point, as specified by the system manufacturer is >500ms.

The signal response time is evaluated as the time required by the system to reach 90% of the expected final value after an on/off switch of the power source with an integration time of 500ms and a probe response time of <5 ms. In the current implementation, DASY5 waits longer than 100ms after having reached the grid point before starting a measurement, i.e., the response time uncertainty is negligible.

If the device under test does not emit a CW signal, the integration time applied to measure the electric field at a specific point may introduce additional uncertainties due to the discretization.
The tolerances for the different systems had the worst-case of 2.6%.

Environmental Conditions

Environmental conditions such as temperature and relative humidity are monitored to ensure there are no impacts on system specifications. Proper voltage and power line frequency conditions are maintained with three phase power sources. Environmental noise and reflections are monitored through system checks.

5. TEST PROCEDURE

I. RF EMISSIONS

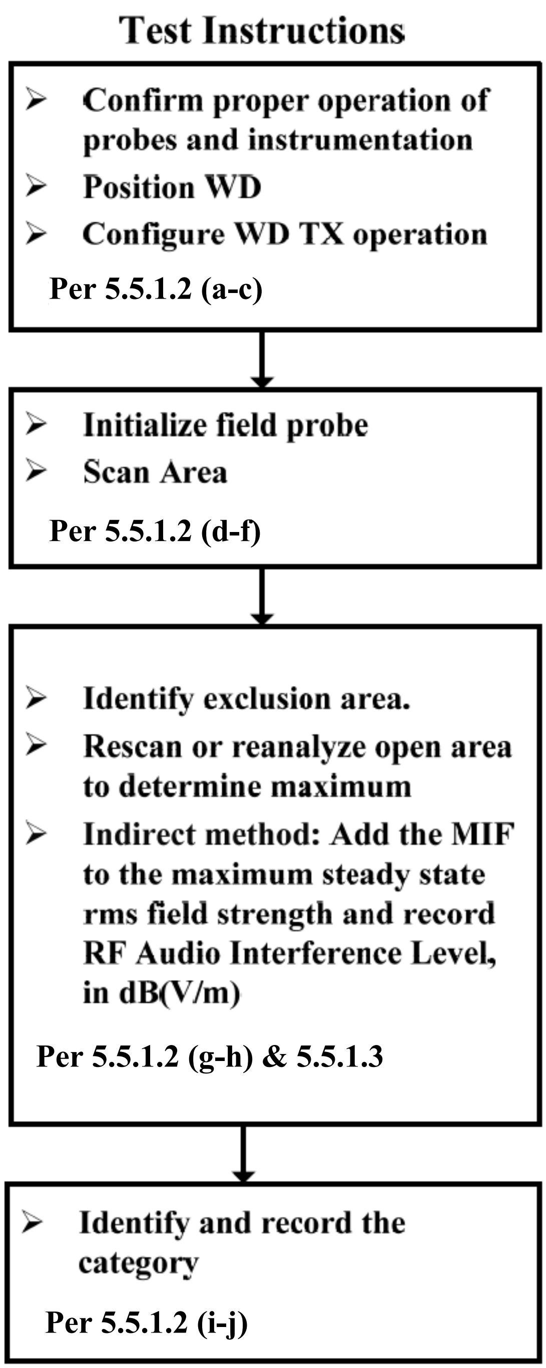


Figure 5-1 RF Emissions Flow Chart

Test Setup

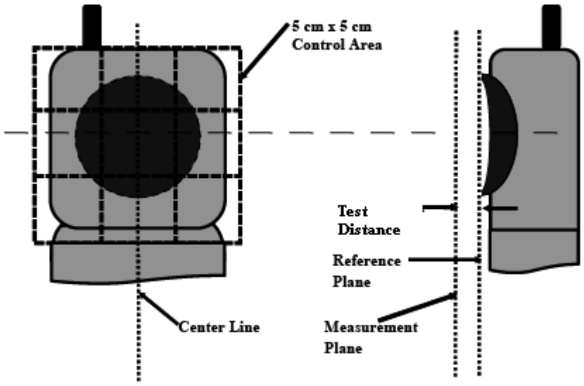


Figure 5-2
E-Field Emissions Test Setup Diagram (See Test Photographs for actual WD scan grid overlay)

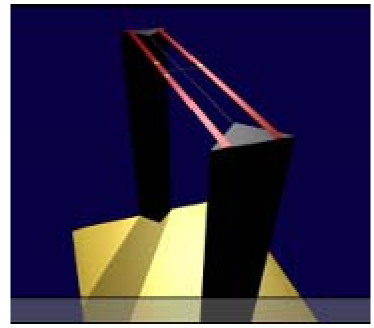


Figure 5-3
HAC Phantom

RF Emissions Test Procedure:

The following illustrate a typical RF emissions test scan over a wireless communications device:

1. Proper operation of the field probe, probe measurement system, other instrumentation, and the positioning system was confirmed.

2. WD is positioned in its intended test position, acoustic output point of the device perpendicular to the field probe.

3. The WD operation for maximum rated RF output power was configured and confirmed with the base station simulator, at the test channel and other normal operating parameters as intended for the test. The battery was ensured to be fully charged before each test.

4. The center sub-grid was centered over the center of the acoustic output (also audio band magnetic output, if applicable). The WD audio output was positioned tangent (as physically possible) to the measurement plane.

5. A surface calibration was performed before each setup change to ensure repeatable spacing and proper maintenance of the measurement plane using the HAC Phantom.

6. The measurement system measured the field strength at the reference location.

7. Measurements at 2mm or 5mm increments in the 5 x 5 cm region were performed at a distance 15 mm from the center point of the probe measurement element to the WD. Of the 9 subgrids (see Figure 5-2), 3 contiguous subgrids may be excluded from the measurement in order to account for localized areas of higher field intensities. The center subgrid containing the acoustic output or audio band magnetic output may not excluded. A 360° rotation about the azimuth axis at the maximum interpolated position was measured. For the worst-case condition, the peak reading from this rotation was used in re-evaluating the HAC category.

8. The system performed a drift evaluation by measuring the field at the reference location. If the power drift deviated by more than 5%, the HAC test and drift measurements were repeated.

6. SYSTEM CHECK

I. System Check Parameters

The input signal was an un-modulated continuous wave. The following points were taken into consideration in performing this check:

- Average Input Power P = 100mW RMS (20dBm RMS) after adjustment for return loss
- The test fixture must meet the 2 wavelength separation criterion
- The proper measurement of the 15 mm probe to dipole separation, which is measured from top surface of the dipole to the calibration reference point of the sensor, defined by the probe manufacturer is shown in the following diagram:

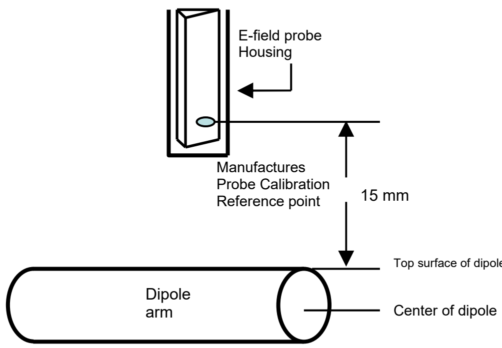


Figure 6-1
Separation Distance from Dipole to Field Probe

RF power was recorded using both an average reading meter and a peak reading meter. Readings of the probe are provided by the measurement system.

To assure proper operation of the near-field measurement probe the input power to the dipole shall be commensurate with the full rated output power of the wireless device [e.g. - for a cellular phone wireless device the average peak antenna input power will be on the order of 100mW (20dBm) RMS] after adjustment for any mismatch.

II. Validation Procedure

A dipole antenna meeting the requirements given in C63.19 was placed in the position normally occupied by the WD.

The length of the dipole was scanned, and the average peak value was recorded.

Measurement of CW

Using the near-field measurement system, scan the antenna over the radiating dipole and record the greatest field reading observed. Due to the nature of E-fields about free-space dipoles, the two E-field peaks measured over the dipole are averaged to compensate for non-parallelity of the setup (see manufacturer method on dipole calibration certificates, page 2). Field strength measurements shall be made only when the probe is stationary.

RF power was recorded using both an average and a peak power reading meter.

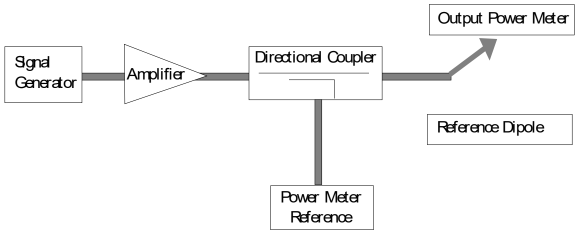


Figure 6-2
Setup for Desired Output Power to Dipole

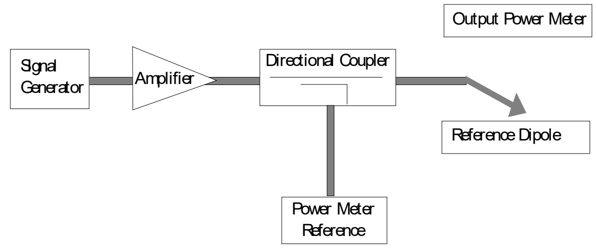


Figure 6-3
Setup to Dipole

Using this setup configuration, the signal generator was adjusted for the desired output power (100mW) at a specified frequency. The reference power from the coupled port of the directional coupler is recorded. Next, the output cable is connected to the reference dipole, as shown in Figure 6-3.

The input signal level was adjusted until the reference power from the coupled port of the directional coupler was the same as previously recorded, to compensate for the impedance mismatch between the output cable and the reference dipole. To assure proper operation of the near-field measurement probe the input power to the reference dipole was verified to the full rated output power of the wireless device. The dipole was secured in a holder in a manner to meet the 20 dB reflection. The near-field measurement probe was positioned over the dipole. The antenna was scanned over the appropriately sized area to cover the dipole from end to end. SPEAG uses 2D interpolation algorithms between the measured points. Please see below two-dimensional plots showing that the interpolated values interpolate smoothly between 5mm steps for a free-space RF dipole:

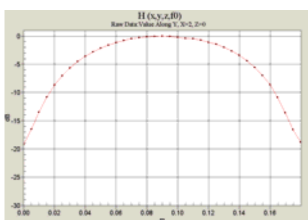


Figure 6-4
2-D Raw Data from scan along dipole axis

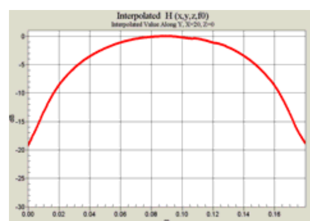


Figure 6-5
2-D Interpolated points from scan along dipole axis

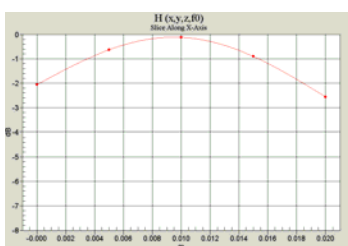


Figure 6-6
2-D Raw Data from scan along transverse axis

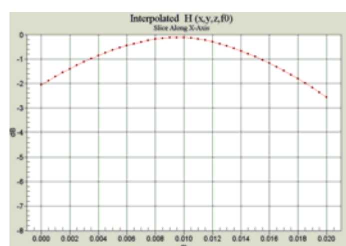


Figure 6-7
2-D Interpolated points from scan along transverse axis

III. System Check Results

Table 6-1
RFE System Verification Results

Date	Frequency (MHz)	Probe S/N	DAE S/N	Dipole S/N	Input Power (dBm)	E-field Result (V/m)	Target Field (V/m)	% Deviation
9/26/2022	835	4035	1533	1003	20.0	115.2	**108.4**	**6.2%**
9/26/2022	1880			1137	20.0	91.7	**87.9**	**4.3%**
9/26/2022	2600			1012	20.0	91.6	**86.5**	**5.9%**
10/10/2022	2600			1012	20.0	86.4	**86.5**	**-0.1%**
10/31/2022	2600			1012	20.0	88.4	**86.5**	**2.2%**
9/26/2022	3500			1015	20.0	84.8	**82.8**	**2.4%**
10/31/2022	3500			1015	20.0	84.5	**82.8**	**2.1%**
10/31/2022	3900			1015	20.0	84.1	**80.9**	**4.0%**

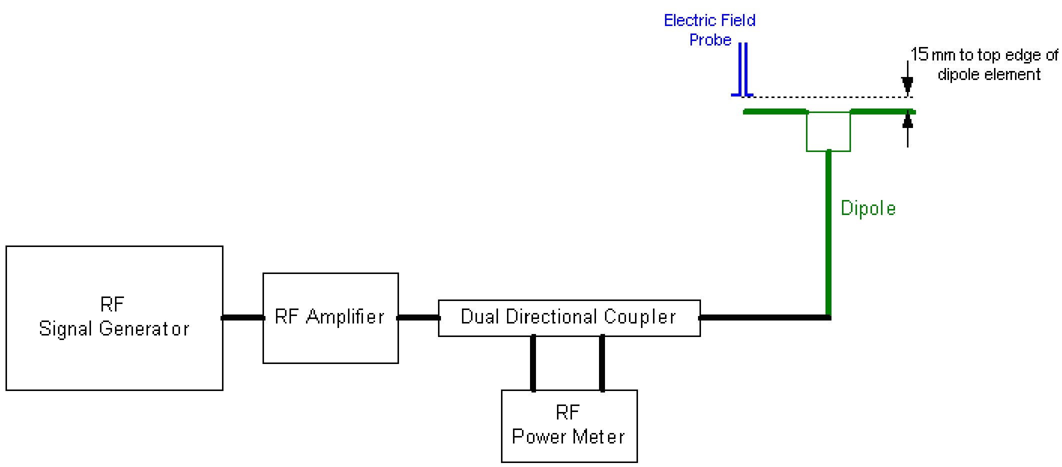


Figure 6-8
System Check Setup

7. MODULATION INTERFERENCE FACTOR

I. Measuring Modulation Interference Factors

For any specific fixed and repeatable modulated signal, a modulation interference factor (MIF, expressed in dB) may be determined that relates its interference potential to its steady-state RMS signal level or average power level. This factor is a function only of the audio-frequency amplitude modulation characteristics of the signal and is the same for field-strength and conducted power measurements. The MIF is valid only for a specific repeatable audio-frequency amplitude modulation characteristic; any change in modulation characteristic requires determination and application of a new MIF.

The MIF may be determined using a radiated RF field or a conducted RF signal:

a. Using RF illumination or conducted coupling, apply the specific modulated signal in question to the measurement system at a level within its confirmed operating dynamic range.
b. Measure the steady-state RMS level at the output of the fast probe or sensor.
c. Measure the steady-state average level at the weighting output.
d. Without changing the square-law detector or weighting system, and using RF illumination or conducted coupling, substitute for the specific modulated signal a 1 kHz, 80% amplitude modulated carrier at the same frequency and adjust its strength until the level at the weighting output equals the step c) measurement.
e. Without changing the carrier level from step d), remove the 1 kHz modulation and again measure the steady-state RMS level indicated at the output of the fast probe or sensor.
f. The MIF for the specific modulation characteristic is provided by the ratio of the step e) measurement to the step b) measurement, expressed in dB (20 × log[(step e)/(step b)]).

The following procedure was used to measure the MIF using the SPEAG Audio Interference Analyzer (AIA), Type No: SE UMS 170 CB, Serial No.: 1010:

1. The device was placed into a simulated call using a base station simulator or set to transmit using test software for a given mode.
2. The device was then set to continuously transmit at maximum power.
3. Using a coupler if needed, the device output signal was connected to the RF In port of the AIA, which was connected to a desktop computer. Alternatively, a radiated RF signal may be used with the AIA's built-in antenna.
4. The MIF measurement procedure in the DASY software was run, and the resulting MIF value was recorded.
5. Steps 1-4 were repeated for all CMRS air interfaces, frequency bands, and modulations.

The modulation interference factors obtained were applied to readings taken of the actual wireless device in order to obtain an accurate audio interference level reading using the formula:

Audio Interference Level [dB(V/m)] = 20 * log[Raw Field Value (V/m)] + MIF (dB)

Because the MIF value is output power independent, MIF values for a given mode should be constant across all devices; however, per C63.19-2011 §D.7, MIF values should be measured for each device being evaluated. The applicable modes for this device have been investigated in this section of the report.

II. MIF Measurement Block Diagrams

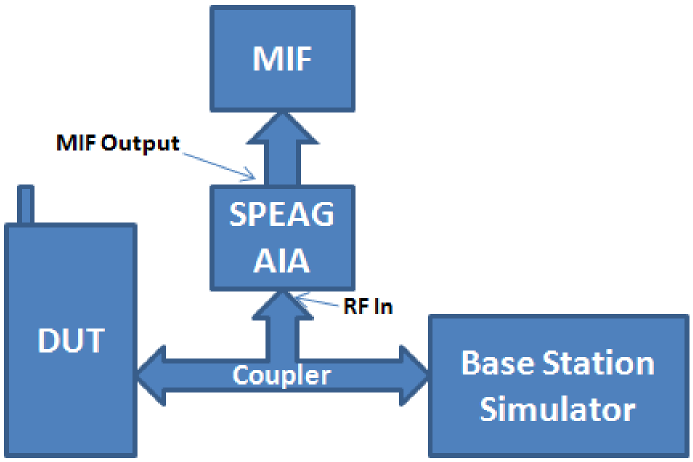


Figure 7-1
MIF Measurement Setup
for licensed modes

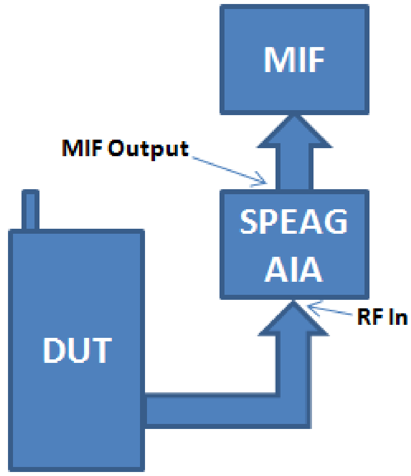


Figure 7-2
MIF Measurement Setup
for unlicensed modes

III. Measured Modulation Interference Factors:

Table 7-1
GSM Modulation Interference Factors[1]

Mode		GSM850			GSM1900		
		128	190	251	512	661	810
GSM	Voice	3.57	3.57	3.57	3.58	3.58	3.58
	EDGE	3.79	3.77	3.75	3.72	3.73	3.71

Table 7-2
UMTS Modulation Interference Factors[1]

Mode		UMTS V			UMTS IV			UMTS II		
		4132	4183	4233	1312	1412	1513	9262	9400	9538
UMTS	12.2 kbps RMC	-23.46	-25.04	-23.70	-23.97	-23.87	-24.01	-23.60	-24.37	-23.88
	12.2 kbps AMR	-13.95	-13.68	-13.64	-13.70	-13.57	-13.50	-13.94	-13.67	-13.74
	HSUPA Subtest1	-23.50	-23.04	-23.21	-23.29	-23.32	-23.43	-23.64	-23.31	-23.47

[1] Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

Table 7-3
LTE FDD Modulation Interference Factors[1,2]

LTE Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	MIF [dB]
71	680.5	133297	20	16QAM	1	0	-9.86
12	707.5	23095	10	16QAM	1	0	-9.86
13	782.0	23230	10	16QAM	1	0	-10.37
14	793.0	23330	10	16QAM	1	0	-9.70
26	831.5	26865	15	16QAM	1	0	-9.73
5	836.5	20525	10	16QAM	1	0	-9.81
4	1732.5	20175	20	16QAM	1	0	-9.63
66	1745.0	132322	20	16QAM	1	0	-9.67
2	1880.0	18900	20	16QAM	1	0	-9.85
25	1882.5	26365	20	16QAM	1	0	-9.86
30	2310.0	27710	10	16QAM	1	0	-9.77
7	2535.0	21100	20	16QAM	1	0	-9.58
7	2535.0	21100	20	QPSK	1	0	-13.95
7	2535.0	21100	20	64QAM	1	0	-9.29
7	2535.0	21100	20	256QAM	1	0	-9.20
7	2535.0	21100	20	256QAM	1	50	-9.18
7	2535.0	21100	20	256QAM	1	99	-9.23
7	2535.0	21100	20	256QAM	50	0	-16.75
7	2535.0	21100	20	256QAM	100	0	-17.59
7	2535.0	21100	15	256QAM	1	36	-9.20
7	2535.0	21100	10	256QAM	1	25	-9.20
7	2535.0	21100	5	256QAM	1	12	-9.25
7	2510.0	20850	20	256QAM	1	50	-9.17
7	2560.0	21350	20	256QAM	1	50	-9.29

Table 7-4
LTE FDD Uplink Carrier Aggregation Modulation Interference Factor[1,3]

Combination	PCC							SCC							MIF (dB)
	PCC Band	PCC Bandwidth [MHz]	PCC (UL) Channel	PCC (UL) Frequency [MHz]	Modulation	PCC UL# RB	PCC UL RB Offset	SCC Band	SCC Bandwidth [MHz]	SCC (UL) Channel	SCC (UL) Frequency [MHz]	Modulation	SCC UL# RB	SCC UL RB Offset	
CA_5B	LTE B5	10	20525	836.5	16QAM	1	0	LTE B5	5	20453	829.3	16QAM	1	24	-9.88
CA_66B	LTE B66	10	132322	1745.0	16QAM	1	0	LTE B66	10	132223	1735.1	16QAM	1	49	-9.78
CA_66C	LTE B66	20	132322	1745.0	16QAM	1	0	LTE B66	20	132124	1725.2	16QAM	1	99	-9.75

[1] Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

[2] Note: All FDD LTE bands were found to have substantially similar MIF values given similar RB, BW, and modulation configurations.

[3] Note: LTE FDD ULCA was evaluated to ensure LTE FDD standalone was the worst-case scenario. The configurations in Table 7-4 were determined from Table 7-3 and satisfy the configuration requirements as defined in 3GPP 36.101.

Table 7-5
LTE TDD B41 Power Class 3 Modulation Interference Factors[1,2]

LTE Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	MIF [dB]
41	2593.0	40620	20	QPSK	1	0	3.66
41	2593.0	40620	20	16QAM	1	0	3.74
41	2593.0	40620	20	64QAM	1	0	3.73
41	2593.0	40620	20	256QAM	1	0	3.52
41	2593.0	40620	20	16QAM	1	50	3.78
41	2593.0	40620	20	16QAM	1	99	3.75
41	2593.0	40620	20	16QAM	50	0	3.52
41	2593.0	40620	20	16QAM	100	0	3.52
41	2593.0	40620	15	16QAM	1	36	3.75
41	2593.0	40620	10	16QAM	1	25	3.75
41	2593.0	40620	5	16QAM	1	12	3.76
41	2506.0	39750	20	16QAM	1	50	3.81
41	2549.5	40185	20	16QAM	1	50	3.83
41	2636.5	41055	20	16QAM	1	50	3.79
41	2680.0	41490	20	16QAM	1	50	3.79

Table 7-6
LTE TDD B41 Power Class 2 Modulation Interference Factors[1,2]

LTE Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	MIF [dB]
41	2593.0	40620	20	QPSK	1	0	3.70
41	2593.0	40620	20	16QAM	1	0	3.81
41	2593.0	40620	20	64QAM	1	0	3.76
41	2593.0	40620	20	256QAM	1	0	3.64
41	2593.0	40620	20	16QAM	1	50	3.83
41	2593.0	40620	20	16QAM	1	99	3.81
41	2593.0	40620	20	16QAM	50	0	3.59
41	2593.0	40620	20	16QAM	100	0	3.59
41	2593.0	40620	15	16QAM	1	36	3.82
41	2593.0	40620	10	16QAM	1	25	3.81
41	2593.0	40620	5	16QAM	1	12	3.80
41	2506.0	39750	20	16QAM	1	50	3.84
41	2549.5	40185	20	16QAM	1	50	3.85
41	2636.5	41055	20	16QAM	1	50	3.85
41	2680.0	41490	20	16QAM	1	50	3.85

[1] Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

[2] Note: LTE TDD MIFs were taken using UL-DL Configuration 5. More information about the chosen UL-DL Configuration can be found in Section 10.

Table 7-7
LTE TDD B48 Modulation Interference Factors[1,2]

LTE Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	MIF [dB]
48	3625.0	55990	20	QPSK	1	0	3.60
48	3625.0	55990	20	16QAM	1	0	3.67
48	3625.0	55990	20	64QAM	1	0	3.60
48	3625.0	55990	20	256QAM	1	0	3.39
48	3625.0	55990	20	16QAM	1	50	3.76
48	3625.0	55990	20	16QAM	1	99	3.68
48	3625.0	55990	20	16QAM	50	0	3.46
48	3625.0	55990	20	16QAM	100	0	3.45
48	3625.0	55990	15	16QAM	1	36	3.69
48	3625.0	55990	10	16QAM	1	0	3.69
48	3625.0	55990	5	16QAM	1	0	3.69
48	3560.0	55340	20	16QAM	1	50	3.75
48	3592.5	55665	20	16QAM	1	50	3.72
48	3657.5	56315	20	16QAM	1	50	3.72
48	3690.0	56640	20	16QAM	1	50	3.78

Table 7-8
LTE TDD Uplink Carrier Aggregation Modulation Interference Factor[1,2,3]

Combination	PCC							SCC							MIF (dB)
	PCC Band	PCC Bandwidth [MHz]	PCC (UL/DL) Channel	PCC (UL/DL) Frequency [MHz]	Modulation	PCC UL# RB	PCC UL RB Offset	SCC Band	SCC Bandwidth [MHz]	SCC (UL/DL) Channel	SCC (UL/DL) Frequency [MHz]	Modulation	SCC UL# RB	SCC UL RB Offset	
CA_41C (PC3)	LTE B41	20	40620	2593.0	16QAM	1	0	LTE B41	20	40422	2573.2	16QAM	1	99	3.67
CA_41C (PC2)	LTE B41	20	40620	2593.0	16QAM	1	0	LTE B41	20	40422	2573.2	16QAM	1	99	3.77
CA_48C	LTE B48	20	55773	2593.0	16QAM	1	0	LTE B48	20	55575	2573.2	16QAM	1	99	3.65

[1] Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

[2] Note: LTE TDD MIFs were taken using UL-DL Configuration 5. More information about the chosen UL-DL Configuration can be found in Section 10.

[3] Note: LTE TDD ULCA was evaluated to ensure LTE TDD standalone was the worst-case scenario. The configurations in Table 7-8 were determined from Tables 7-5 through 7-7 and satisfy the configuration requirements as defined in 3GPP 36.101. These MIFs were evaluated with UL-DL Configuration 5 for Power Class 3 LTE TDD and UL-DL Configuration 5 for Power Class 2 LTE TDD.

Table 7-9
NR FDD Modulation Interference Factors[1,2]

NR Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Waveform	Modulation	RB Size	RB Offset	MIF [dB]
n71	680.5	136100	20	DFT-s-OFDM	16QAM	1	1	-13.56
n12	707.5	141500	15	DFT-s-OFDM	16QAM	1	1	-10.07
n5	836.5	167300	20	DFT-s-OFDM	16QAM	1	1	-11.79
n26	831.5	166300	20	DFT-s-OFDM	16QAM	1	1	-10.93
n66	1745.0	349000	40	DFT-s-OFDM	16QAM	1	1	-10.76
n2	1880.0	376000	20	DFT-s-OFDM	16QAM	1	1	-11.59
n25	1882.5	376500	40	DFT-s-OFDM	16QAM	1	1	-9.54
n7	2535.0	507000	40	DFT-s-OFDM	16QAM	1	1	-8.90
n30	2310.0	462000	10	DFT-s-OFDM	16QAM	1	1	-9.84
n7	2535.0	507000	40	DFT-s-OFDM	π/2-BPSK	1	1	-17.37
n7	2535.0	507000	40	DFT-s-OFDM	QPSK	1	1	-16.03
n7	2535.0	507000	40	DFT-s-OFDM	64QAM	1	1	-10.75
n7	2535.0	507000	40	DFT-s-OFDM	256QAM	1	1	-11.72
n7	2535.0	507000	40	CP-OFDM	QPSK	1	1	-11.50
n7	2535.0	507000	40	CP-OFDM	16QAM	1	1	-8.71
n7	2535.0	507000	40	CP-OFDM	64QAM	1	1	-9.03
n7	2535.0	507000	40	CP-OFDM	256QAM	1	1	-10.14
n7	2535.0	507000	40	CP-OFDM	16QAM	1	108	-10.37
n7	2535.0	507000	40	CP-OFDM	16QAM	1	214	-10.11
n7	2535.0	507000	40	CP-OFDM	16QAM	108	0	-20.38
n7	2535.0	507000	40	CP-OFDM	16QAM	216	0	-21.36
n7	2535.0	507000	30	CP-OFDM	16QAM	1	1	-10.80
n7	2535.0	507000	25	CP-OFDM	16QAM	1	1	-10.79
n7	2535.0	507000	20	CP-OFDM	16QAM	1	1	-11.92
n7	2535.0	507000	15	CP-OFDM	16QAM	1	1	-10.82
n7	2535.0	507000	10	CP-OFDM	16QAM	1	1	-10.57
n7	2535.0	507000	5	CP-OFDM	16QAM	1	1	-9.43
n7	2520.0	504000	40	CP-OFDM	16QAM	1	1	-11.01
n7	2550.0	510000	40	CP-OFDM	16QAM	1	1	-9.59

[1] Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

[2] Note: All FDD NR bands were found to have substantially similar MIF values given similar RB, BW, and modulation configurations.

Table 7-10
NR TDD n41 Power Class 2 Modulation Interference Factors[1]

NR Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Waveform	Modulation	RB Size	RB Offset	MIF [dB]
n41	2593.0	518598	100	DFT-s-OFDM	π/2-BPSK	1	1	1.38
n41	2593.0	518598	100	DFT-s-OFDM	QPSK	1	1	1.36
n41	2593.0	518598	100	DFT-s-OFDM	16QAM	1	1	1.35
n41	2593.0	518598	100	DFT-s-OFDM	64QAM	1	1	1.39
n41	2593.0	518598	100	DFT-s-OFDM	256QAM	1	1	1.36
n41	2593.0	518598	100	CP-OFDM	QPSK	1	1	1.26
n41	2593.0	518598	100	CP-OFDM	16QAM	1	1	1.26
n41	2593.0	518598	100	CP-OFDM	64QAM	1	1	1.29
n41	2593.0	518598	100	CP-OFDM	256QAM	1	1	1.29
n41	2593.0	518598	100	DFT-s-OFDM	64QAM	1	137	1.39
n41	2593.0	518598	100	DFT-s-OFDM	64QAM	1	271	1.39
n41	2593.0	518598	100	DFT-s-OFDM	64QAM	135	0	1.38
n41	2593.0	518598	100	DFT-s-OFDM	64QAM	270	0	1.37
n41	2593.0	518598	90	DFT-s-OFDM	64QAM	1	1	1.35
n41	2593.0	518598	80	DFT-s-OFDM	64QAM	1	1	1.37
n41	2593.0	518598	70	DFT-s-OFDM	64QAM	1	1	1.44
n41	2593.0	518598	60	DFT-s-OFDM	64QAM	1	1	1.40
n41	2593.0	518598	50	DFT-s-OFDM	64QAM	1	1	1.36
n41	2593.0	518598	40	DFT-s-OFDM	64QAM	1	1	1.35
n41	2593.0	518598	30	DFT-s-OFDM	64QAM	1	1	1.32
n41	2593.0	518598	20	DFT-s-OFDM	64QAM	1	1	1.35
n41	2593.0	518598	15	DFT-s-OFDM	64QAM	1	1	1.38
n41	2593.0	518598	10	DFT-s-OFDM	64QAM	1	1	1.31
n41	2531.0	506202	70	DFT-s-OFDM	64QAM	1	1	1.42
n41	2562.0	512400	70	DFT-s-OFDM	64QAM	1	1	1.41
n41	2624.0	524802	70	DFT-s-OFDM	64QAM	1	1	1.41
n41	2655.0	531000	70	DFT-s-OFDM	64QAM	1	1	1.40

Table 7-11
NR TDD n77 DoD Modulation Interference Factors[1]

NR Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Waveform	Modulation	RB Size	RB Offset	MIF [dB]
n77 DoD	3500.0	633334	100	DFT-s-OFDM	π/2-BPSK	1	1	1.37
n77 DoD	3500.0	633334	100	DFT-s-OFDM	QPSK	1	1	1.37
n77 DoD	3500.0	633334	100	DFT-s-OFDM	16QAM	1	1	1.35
n77 DoD	3500.0	633334	100	DFT-s-OFDM	64QAM	1	1	1.27
n77 DoD	3500.0	633334	100	DFT-s-OFDM	256QAM	1	1	1.39
n77 DoD	3500.0	633334	100	CP-OFDM	QPSK	1	1	1.26
n77 DoD	3500.0	633334	100	CP-OFDM	16QAM	1	1	1.33
n77 DoD	3500.0	633334	100	CP-OFDM	64QAM	1	1	1.25
n77 DoD	3500.0	633334	100	CP-OFDM	256QAM	1	1	1.21
n77 DoD	3500.0	633334	100	DFT-s-OFDM	256QAM	1	137	1.22
n77 DoD	3500.0	633334	100	DFT-s-OFDM	256QAM	1	271	1.21
n77 DoD	3500.0	633334	100	DFT-s-OFDM	256QAM	135	0	1.25
n77 DoD	3500.0	633334	100	DFT-s-OFDM	256QAM	270	0	1.33
n77 DoD	3500.0	633334	90	DFT-s-OFDM	256QAM	1	1	1.22
n77 DoD	3500.0	633334	80	DFT-s-OFDM	256QAM	1	1	1.23
n77 DoD	3500.0	633334	70	DFT-s-OFDM	256QAM	1	1	1.23
n77 DoD	3500.0	633334	60	DFT-s-OFDM	256QAM	1	1	1.16
n77 DoD	3500.0	633334	50	DFT-s-OFDM	256QAM	1	1	1.19
n77 DoD	3500.0	633334	40	DFT-s-OFDM	256QAM	1	1	1.18
n77 DoD	3500.0	633334	30	DFT-s-OFDM	256QAM	1	1	1.24
n77 DoD	3500.0	633334	25	DFT-s-OFDM	256QAM	1	1	1.26
n77 DoD	3500.0	633334	20	DFT-s-OFDM	256QAM	1	1	1.21
n77 DoD	3500.0	633334	15	DFT-s-OFDM	256QAM	1	1	1.29
n77 DoD	3500.0	633334	10	DFT-s-OFDM	256QAM	1	1	1.21

[1] Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

Table 7-12
NR TDD n48 Modulation Interference Factors[1]

NR Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Waveform	Modulation	RB Size	RB Offset	MIF [dB]
n48	3625.0	641666	40	DFT-s-OFDM	π/2-BPSK	1	1	1.39
n48	3625.0	641666	40	DFT-s-OFDM	QPSK	1	1	1.34
n48	3625.0	641666	40	DFT-s-OFDM	16QAM	1	1	1.33
n48	3625.0	641666	40	DFT-s-OFDM	64QAM	1	1	1.31
n48	3625.0	641666	40	DFT-s-OFDM	256QAM	1	1	1.35
n48	3625.0	641666	40	CP-OFDM	16QAM	1	1	1.27
n48	3625.0	641666	40	CP-OFDM	QPSK	1	1	1.16
n48	3625.0	641666	40	CP-OFDM	64QAM	1	1	1.31
n48	3625.0	641666	40	CP-OFDM	256QAM	1	1	1.15
n48	3625.0	641666	40	DFT-s-OFDM	π/2-BPSK	1	53	1.39
n48	3625.0	641666	40	DFT-s-OFDM	π/2-BPSK	1	104	1.39
n48	3625.0	641666	40	DFT-s-OFDM	π/2-BPSK	50	0	1.40
n48	3625.0	641666	40	DFT-s-OFDM	π/2-BPSK	100	0	1.41
n48	3625.0	641666	30	DFT-s-OFDM	π/2-BPSK	75	0	1.38
n48	3625.0	641666	20	DFT-s-OFDM	π/2-BPSK	50	0	1.42
n48	3625.0	641666	15	DFT-s-OFDM	π/2-BPSK	36	0	1.40
n48	3625.0	641666	10	DFT-s-OFDM	π/2-BPSK	24	0	1.41
n48	3560.0	637334	20	DFT-s-OFDM	π/2-BPSK	50	0	1.40
n48	3592.5	639500	20	DFT-s-OFDM	π/2-BPSK	50	0	1.40
n48	3657.5	643834	20	DFT-s-OFDM	π/2-BPSK	50	0	1.40
n48	3690.0	646000	20	DFT-s-OFDM	π/2-BPSK	50	0	1.40

Table 7-13
NR TDD n77 Modulation Interference Factors[1]

NR Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Waveform	Modulation	RB Size	RB Offset	MIF [dB]
n77	3840.0	656000	100	DFT-s-OFDM	π/2-BPSK	1	1	1.38
n77	3840.0	656000	100	DFT-s-OFDM	QPSK	1	1	1.36
n77	3840.0	656000	100	DFT-s-OFDM	16QAM	1	1	1.34
n77	3840.0	656000	100	DFT-s-OFDM	64QAM	1	1	1.27
n77	3840.0	656000	100	DFT-s-OFDM	256QAM	1	1	1.36
n77	3840.0	656000	100	CP-OFDM	QPSK	1	1	1.24
n77	3840.0	656000	100	CP-OFDM	16QAM	1	1	1.32
n77	3840.0	656000	100	CP-OFDM	64QAM	1	1	1.27
n77	3840.0	656000	100	CP-OFDM	256QAM	1	1	1.32
n77	3840.0	656000	100	DFT-s-OFDM	π/2-BPSK	1	137	1.39
n77	3840.0	656000	100	DFT-s-OFDM	π/2-BPSK	1	271	1.39
n77	3840.0	656000	100	DFT-s-OFDM	π/2-BPSK	135	0	1.41
n77	3840.0	656000	100	DFT-s-OFDM	π/2-BPSK	270	0	1.38
n77	3840.0	656000	90	DFT-s-OFDM	π/2-BPSK	120	0	1.38
n77	3840.0	656000	80	DFT-s-OFDM	π/2-BPSK	108	0	1.37
n77	3840.0	656000	70	DFT-s-OFDM	π/2-BPSK	90	0	1.37
n77	3840.0	656000	60	DFT-s-OFDM	π/2-BPSK	81	0	1.38
n77	3840.0	656000	50	DFT-s-OFDM	π/2-BPSK	64	0	1.41
n77	3840.0	656000	40	DFT-s-OFDM	π/2-BPSK	50	0	1.38
n77	3840.0	656000	30	DFT-s-OFDM	π/2-BPSK	36	0	1.37
n77	3840.0	656000	25	DFT-s-OFDM	π/2-BPSK	32	0	1.37
n77	3840.0	656000	20	DFT-s-OFDM	π/2-BPSK	25	0	1.37
n77	3840.0	656000	15	DFT-s-OFDM	π/2-BPSK	18	0	1.37
n77	3840.0	656000	10	DFT-s-OFDM	π/2-BPSK	12	0	1.37
n77	3750.0	650000	100	DFT-s-OFDM	π/2-BPSK	135	0	1.39
n77	3795.0	653000	100	DFT-s-OFDM	π/2-BPSK	135	0	1.42
n77	3885.0	659000	100	DFT-s-OFDM	π/2-BPSK	135	0	1.42
n77	3930.0	662000	100	DFT-s-OFDM	π/2-BPSK	135	0	1.42

[1] Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

Table 7-14

802.11b (2.4GHz, SISO) Modulation Interference Factors[1,2]

Mode	802.11b MIF Measurements [dB]			
	Data Rate [Mbps]			
	1	2	5.5	11
802.11b	-10.04	-9.26	-7.37	-6.27

Table 7-15

802.11b (2.4GHz, MIMO) Modulation Interference Factors[1,2]

Mode	802.11b MIF Measurements [dB]			
	Data Rate [Mbps]			
	2	4	11	22
802.11b	-9.98	-9.25	-6.78	-5.92

Table 7-16

802.11g (2.4GHz, SISO) Modulation Interference Factors[1,2]

Mode	802.11g MIF Measurements [dB]							
	Data Rate [Mbps]							
	6	9	12	18	24	36	48	54
802.11g	-7.34	-6.60	-6.06	-5.26	-4.86	-4.44	-4.43	-3.79

Table 7-17

802.11g (2.4GHz, MIMO) Modulation Interference Factors[1,2]

Mode	802.11g MIF Measurements [dB]							
	Data Rate [Mbps]							
	12	18	24	36	48	72	96	108
802.11g	-7.36	-6.58	-6.07	-5.24	-4.84	-4.42	-4.43	-3.77

Table 7-18

802.11n (2.4GHz, SISO) Modulation Interference Factors[1,2]

Mode	802.11n (2.4GHz) MIF Measurements [dB]							
	MCS Index							
	0	1	2	3	4	5	6	7
802.11n	-7.11	-5.92	-5.11	-4.64	-4.40	-3.78	-3.32	-3.37

Table 7-19

802.11n (2.4GHz, MIMO) Modulation Interference Factors[1,2]

Mode	802.11n (2.4GHz) MIF Measurements [dB]							
	MCS Index							
	0	1	2	3	4	5	6	7
802.11n	-7.25	-6.09	-5.28	-4.82	-4.54	-3.85	-3.40	-2.97

Table 7-20

802.11ax (2.4GHz, SU, SISO) Modulation Interference Factors[1,2]

Mode	20MHz 802.11ax (2.4GHz) MIF Measurements [dB]											
	MCS Index											
	0	1	2	3	4	5	6	7	8	9	10	11
802.11ax	-16.44	-16.85	-17.05	-15.84	-16.15	-16.14	-16.17	-16.22	-15.74	-16.11	N/A	N/A

[1] Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

[2] Note: WIFI MIF values were found to be independent of the transmit channel.

Table 7-21
802.11ax (2.4GHz, SU, MIMO) Modulation Interference Factors[1,2]

Mode	20MHz 802.11ax (2.4GHz) MIF Measurements [dB]											
	MCS Index											
	0	1	2	3	4	5	6	7	8	9	10	11
802.11ax	-16.67	-17.22	-17.25	-16.99	-16.22	-16.50	-16.87	-16.60	-16.81	-16.94	N/A	N/A

Table 7-22
802.11ax (2.4GHz, RU, SISO) Modulation Interference Factors[1,2]

Mode	20MHz 802.11ax (2.4GHz) MIF Measurements [dB]						
	RU Index (MCS Index 8) (GI 1.6us)						
	0	8	37	40	53	54	61
802.11ax	-12.38	-12.36	-12.12	-11.44	-11.82	-11.63	-12.36

Table 7-23
802.11ax (2.4GHz, RU, MIMO) Modulation Interference Factors[1,2]

Mode	20MHz 802.11ax (2.4GHz) MIF Measurements [dB]						
	RU Index (MCS Index 4) (GI 1.6us)						
	0	8	37	40	53	54	61
802.11ax	-12.46	-12.79	-11.58	-10.65	-11.22	-10.63	-11.52

Table 7-24
802.11a (5GHz, 20MHz BW, MIMO) Modulation Interference Factors[1,2]

Mode	802.11a MIF Measurements [dB]							
	Data Rate [Mbps]							
	12	18	24	36	48	72	96	108
802.11a	-7.66	-6.92	-6.38	-5.55	-5.18	-4.80	-4.79	-3.86

Table 7-25
802.11n (5GHz, 20MHz BW, MIMO) Modulation Interference Factors[1,2]

Mode	20MHz BW 802.11n (5GHz) MIF Measurements [dB]							
	MCS Index							
	0	1	2	3	4	5	6	7
802.11n	-7.54	-6.38	-5.56	-5.12	-4.91	-3.90	-3.45	-3.02

Table 7-26
802.11ac (5GHz, 20MHz BW, MIMO) Modulation Interference Factors[1,2]

Mode	20MHz BW 802.11ac (5GHz) MIF Measurements [dB]									
	MCS Index									
	0	1	2	3	4	5	6	7	8	9
802.11ac	-6.20	-5.15	-4.91	-4.13	-2.69	-2.07	-1.88	-1.83	-1.62	-1.63

Table 7-27
802.11ax (5GHz, 20MHz BW, SU, MIMO) Modulation Interference Factors[1,2]

Mode	20MHz 802.11ax (5GHz) MIF Measurements [dB]											
	MCS Index											
	0	1	2	3	4	5	6	7	8	9	10	11
802.11ax	-16.42	-16.77	-16.77	-16.07	-15.62	-15.73	-15.82	-15.78	-15.48	-15.91	-15.78	-15.85

[1] Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

[2] Note: WIFI MIF values were found to be independent of the transmit channel.

Table 7-28
802.11ax (5GHz, 20MHz BW, RU, MIMO) Modulation Interference Factors[1,2]

Mode	20MHz 802.11ax (5GHz) MIF Measurements [dB]						
	RU Index (MCS Index 8) (GI 1.6us)						
	0	8	37	40	53	54	61
802.11ax	-11.77	-12.89	-10.74	-9.73	-9.25	-9.55	-8.67

Table 7-29
802.11n (5GHz, 40MHz BW, MIMO) Modulation Interference Factors[1,2]

Mode	40MHz BW 802.11n (5GHz) MIF Measurements [dB]							
	MCS Index							
	0	1	2	3	4	5	6	7
802.11n	-5.77	-4.73	-4.24	-2.72	-1.70	-1.33	-1.20	-1.14

Table 7-30
802.11ac (5GHz, 40MHz BW, MIMO) Modulation Interference Factors[1,2]

Mode	40MHz BW 802.11ac (5GHz) MIF Measurements [dB]									
	MCS Index									
	0	1	2	3	4	5	6	7	8	9
802.11ac	-5.80	-4.77	-4.63	-3.14	-1.91	-1.48	-1.37	-1.25	N/A	-1.09

Table 7-31
802.11ax (5GHz, 40MHz BW, SU, MIMO) Modulation Interference Factors[1,2]

Mode	40MHz 802.11ax (5GHz) MIF Measurements [dB]											
	MCS Index											
	0	1	2	3	4	5	6	7	8	9	10	11
802.11ax	-15.25	-15.36	-15.34	-15.20	-15.16	-15.36	-15.30	-15.39	-15.28	-15.28	-15.24	-15.43

Table 7-32
802.11ax (5GHz, 40MHz BW, RU, MIMO) Modulation Interference Factors[1,2]

Mode	40MHz 802.11ax (5GHz) MIF Measurements [dB]								
	RU Index (MCS Index 4) (GI 1.6us)								
	0	17	37	44	53	56	61	62	65
802.11ax	-11.68	-13.29	-10.10	-9.93	-7.58	-7.49	-12.79	-7.27	-6.78

Table 7-33
802.11ac (5GHz, 80MHz BW, MIMO) Modulation Interference Factors[1,2]

Mode	80MHz BW 802.11ac (5GHz) MIF Measurements [dB]									
	MCS Index									
	0	1	2	3	4	5	6	7	8	9
802.11ac	-5.97	-4.98	-4.77	-4.96	-3.47	-2.87	-2.68	-2.55	-2.38	-2.36

Table 7-34
802.11ax (5GHz, 80MHz BW, SU, MIMO) Modulation Interference Factors[1,2]

Mode	80MHz 802.11ax (5GHz) MIF Measurements [dB]											
	MCS Index											
	0	1	2	3	4	5	6	7	8	9	10	11
802.11ax	-15.97	-16.04	-15.80	-15.63	-15.61	-15.85	-15.84	-15.79	-15.78	-15.86	-15.87	-15.95

[1] Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

[2] Note: WIFI MIF values were found to be independent of the transmit channel.

Table 7-35

802.11ax (5GHz, 80MHz BW, RU, MIMO) Modulation Interference Factors[1,2]

Mode	80MHz 802.11ax (5GHz) MIF Measurements [dB]										
	RU Index (MCS Index 4) (GI 1.6us)										
	0	36	37	52	53	60	61	64	65	66	67
802.11ax	-11.66	-13.55	-9.04	-10.33	-8.26	-10.67	-11.04	-12.93	-8.90	-9.09	-9.55

Table 7-36

802.11ac (5GHz, 160MHz BW, MIMO) Modulation Interference Factors[1,2]

Mode	160MHz BW 802.11ac (5GHz) MIF Measurements [dB]									
	MCS Index									
	0	1	2	3	4	5	6	7	8	9
802.11ac	-5.56	-4.47	-4.46	-3.88	-2.75	-2.29	-2.10	-1.99	-1.84	-1.81

Table 7-37

802.11ax (5GHz, 160MHz BW, SU, MIMO) Modulation Interference Factors[1,2]

Mode	160MHz 802.11ax (5GHz) MIF Measurements [dB]											
	MCS Index											
	0	1	2	3	4	5	6	7	8	9	10	11
802.11ax	-14.55	-14.51	-14.67	-14.78	-15.04	-15.19	-15.20	-15.19	-15.43	-15.20	-15.00	-15.56

Table 7-38

802.11ax (5GHz, 160MHz BW, RU, MIMO) Modulation Interference Factors[1,2]

Mode	160MHz 802.11ax (5GHz) MIF Measurements [dB]										
	RU Index (MCS Index 1) (GI 1.6us)										
	0	36	37	52	53	60	61	64	65	66	67
802.11ax	-15.02	-14.76	-15.05	-15.04	-14.77	-15.05	-15.05	-15.04	-14.79	-15.04	-15.04

Table 7-39

Simultaneous 2.4GHz and 5GHz WIFI Modulation Interference Factors[1,2,3]

# Tx	5 GHz WIFI [dBm]		2.4 GHz WIFI [dBm]		Measured MIF (dB)
	Ant1	Ant2	Ant1	Ant2	
3	x	x	-	x	-11.96
4	x	x	x	x	-13.31

[1] Note: Measured MIF values may be lower than sample MIF values provided in ANSI C63.19-2011 Annex D.7 Table D.5 due to manufacturing variations for each device, however per Annex D.7, the sample MIF values of Table D.5 are not intended to substitute for measurements of actual devices under test and their respective operating modes.

[2] Note: WLAN MIF values were found to be independent of the transmit channel.

[3] Note: The configuration for each scenario (e.g. bandwidth, data rate, etc.) was determined using the worst-case configuration from SISO and MIMO MIF measurements.

8. CONDUCTED POWER CONFIGURATIONS AND TARGETS

I. Procedures Used to Establish RF Signal for HAC Testing

The handset was configured to transmit the required air interface in a shielded chamber. Measurements were taken with a fully charged battery.

II. HAC Target Powers

All applicable modes supported by the device have their held-to-ear conducted power targets listed below and were used for the individual mode evaluations in Section 9. All conducted power targets have a tolerance of +1.0dB and -1.5dB unless otherwise noted. For WIFI modes, the overall maximum power amongst all bands per IEEE standards is listed and these powers have no lower tolerance.

III. RF Conducted Power Measurement Setup and Conditions

Output Power Verification

Maximum output power is verified for all applicable test channels for all air interfaces which require test scans. See Table 8-1 for air interface specific settings of transmit power parameters. See Table 9-1 for more information regarding which modes required test scans and had conducted power measurements taken.

Table 8-1
Power Control Parameters and Settings by Air Interface

Air Interface:	Parameter Name:	Parameter Set To:
GSM	PCL	GSM850: “5”; GSM1900: “0”
UMTS	TPC	“All 1’s”
LTE	TPC	“Max Power”
NR	PLS	Mfr Specified
WIFI	PLS	Mfr Specified

The general setup for conducted powers included in Section 11 is shown in Figure 8-1 below. The power measurement equipment could be a base station simulator, signal analyzer, or power meter depending on the applicable air interface.

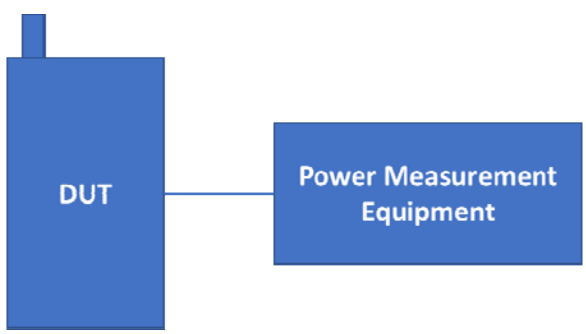


Figure 8-1
Power Measurement Setup

IV. GSM Target Powers

Table 8-2
GSM Conducted Power Targets

Band	Modulated Average Output Power (in dBm)	
	Voice	Data
GSM/EDGE 850	32.0	27.0
GSM/EDGE 1900	29.0	26.0

V. UMTS Target Powers

Table 8-3
UMTS Conducted Power Targets

Band	Modulated Average Output Power (in dBm)	
	3GPP WCDMA Rel 99	3GPP HSUPA Rel 6
UMTS V	24.0	23.0
UMTS IV	23.0	22.0
UMTS II	23.0	22.0

VI. LTE FDD Target Powers

Table 8-4
LTE FDD Conducted Power Targets

Band	Modulated Average Output Power (in dBm)
LTE Band 71	24.5
LTE Band 12	24.5
LTE Band 13	24.5
LTE Band 14	24.5
LTE Band 5	24.5
LTE Band 26	24.5
LTE Band 4	23.5
LTE Band 66	23.5
LTE Band 2	23.5
LTE Band 25	23.5
LTE Band 30	22.5
LTE Band 7	23.0

Table 8-5
LTE FDD Uplink Carrier Aggregation Conducted Power Targets

Band	Modulated Average Output Power (in dBm)
LTE Band 5	24.5
LTE Band 66	23.5

VII. LTE TDD Target Powers

Table 8-6
LTE TDD Conducted Power Targets

Band	Modulated Average Output Power (in dBm)
LTE Band 38	24.0
LTE Band 41 PC3	24.0
LTE Band 41 PC2	25.7
LTE Band 48	22.5

Table 8-7
LTE TDD Uplink Carrier Aggregation Conducted Power Targets

Band	Modulated Average Output Power (in dBm)
LTE Band 41 PC3	24.0
LTE Band 41 PC2	25.7
LTE Band 48	22.5

VIII. NR FDD Target Powers

Table 8-8
NR FDD Conducted Power Targets

Band	Modulated Average Output Power (in dBm)
NR Band n71	24.5
NR Band n12	24.5
NR Band n26	24.5
NR Band n5	24.5
NR Band n66	23.5
NR Band n2	23.5
NR Band n25	23.5
NR Band n7	23.0
NR Band n30	22.5

IX. NR TDD Target Powers

Table 8-9
NR TDD Conducted Power Targets

Band	Modulated Average Output Power (in dBm)
NR Band n38	24.0
NR Band n41 PC2	26.0
NR Band n48	22.5
NR Band n77	26.0
NR Band n77 (DoD)	26.0

X. WIFI Target Powers

Table 8-10
IEEE 802.11a/b/g/n/ac/ax Reduced Average RF Power Targets

Band	Modulated Average Output Power (in dBm)
WLAN - 2.4GHz	18.0
WLAN - 5GHz	15.0
WLAN - RSDB/DBS	19.8

9. JUSTIFICATION OF HELD TO EAR MODES TESTED

I. Analysis of RF Air Interface Technologies

An analysis was performed, following the guidance of §4.3 and §4.4 of the ANSI standard, of the RF air interface technologies being evaluated. The factors that will affect the RF interference potential were evaluated, and the worst-case operating modes were identified and used in the evaluation. A WD's interference potential is a function both of the WD's average near-field field strength and of the signal's audio-frequency amplitude modulation characteristics. Per §4.4, RF air interface technologies that have low power have been found to produce sufficiently low RF interference potential, so it is possible to exempt them from the product testing specified in Clause 5 of the ANSI standard. An RF air interface technology of a device is exempt from testing when its average antenna input power plus its MIF is ≤17dBm for all of its operating modes. RF air interface technologies exempted from testing in this manner are automatically assigned an M4 rating to be used in determining the overall rating for the WD.

The worst-case MIF plus the worst-case average antenna input power for all modes are investigated below to determine the testing requirements for this device.

II. Individual Mode Evaluations

Table 9-1
Max Power + MIF calculations for Low Power Exemptions

Air Interface	Maximum Average Power (dBm)	Worst Case MIF (dB)	Total (Power + MIF, dB)	C63.19 Testing Required
GSM - GSM850	23.81*	3.57	27.38	Yes
GSM - GSM1900	20.81*	3.58	24.39	Yes
GSM - EDGE850	18.81*	3.79	22.60	Yes***
GSM - EDGE1900	17.81*	3.73	21.54	Yes***
UMTS - RMC	25.00	-23.46	1.54	No
UMTS - AMR	25.00	-13.50	11.50	No
UMTS - HSPA	24.00	-23.04	0.96	No
LTE FDD	25.50	-9.17	16.33	No
LTE FDD - Uplink Carrier Aggregation	24.50	-9.75	14.75	No
LTE TDD - Band 41 (PC3)	15.29*	3.83	19.12	Yes
LTE TDD - Band 41 (PC2)	16.99*	3.85	20.84	Yes
LTE TDD - Band 48	13.79*	3.78	17.57	Yes
LTE TDD - Uplink Carrier Aggregation	16.99*	3.77	20.76	Yes****
NR FDD	25.50	-8.71	16.79	No
NR TDD - n41	20.98*	1.44	22.42	Yes
NR TDD - n77 (DoD)	20.98*	1.39	22.37	Yes
NR TDD - n48	17.48*	1.42	18.90	Yes
NR TDD - n77	20.98*	1.42	22.40	Yes
WIFI - 2.4GHz	19.00	-2.97	16.03	No
WIFI - 5GHz	16.00	-1.09	14.91	No
Simultaneous 2.4GHz and 5GHz WIFI Operations	20.76**	-11.96	8.80	No

* Note: ANSI C63.19-2011 Sec. 4.4 Footnote 20 indicates the use of a long averaging time for measuring the antenna input power when using this method of exclusion. Therefore, the frame averaged power was calculated for these modes in this investigation.

** Note: This value is calculated as the linear sum of the worst-case power for each band and antenna combination while in simultaneous 2.4GHz and 5GHz operation. This calculation is conservative and for use in this investigation only.

*** Note: EDGE data modes were considered but not tested as GSM voice modes were found to be the worst-case modes for the GSM air interface.

**** Note: LTE ULCA data modes were considered but not tested as LTE standalone data modes were found to be the worst-case modes for the LTE air interface.

III. Low-Power Exemption Conclusions

Per ANSI C63.19-2011, RF Emissions testing for this device is required only for GSM voice mode as well as LTE TDD (Power Class 3 and Power Class 2) and NR TDD data modes. All other air interfaces are exempt.

10. LTE TDD UPLINK-DOWNLINK CONFIGURATION

I. Uplink-Downlink Configuration Additional Testing

Additional testing was performed on each supported power class for LTE TDD to determine the worst-case Uplink-Downlink configuration for RFE testing.

Per 3GPP TS 36.211, the total frame length for each TDD radio frame of length $T_f = 307200 \cdot T_s = 10$ ms, where T_s is a number of time units equal to 1/(15000 x 2048) seconds. Additionally, each radio frame consists of 10 subframes, each of length $30720 \cdot T_s = 1$ ms, and subframes can be designated as uplink (U), downlink (D), or special subframe (S), depending on the Uplink-Downlink configuration as indicated in Table 4.2-2 of 3GPP TS 36.211. In the transmission duty factor calculation, the special subframe configuration with the shortest UpPTS duration within the special subframe is used and will be applied for measurement. From 3GPP TS 36.211 Table 4.2-1, the shortest UpPTS is $2192 \cdot Ts$ which occurs in the normal cyclic prefix and special subframe configuration 4.

See table below outlining the calculated transmission duty cycles for each Uplink-Downlink configuration:

Table 10-1
Uplink-Downlink Configurations for Type 2 Frame Structures

Uplink-downlink configuration	Downlink-to-Uplink Switch-point periodicity	Subframe number										Calculated Transmission Duty Cycle (%)
		0	1	2	3	4	5	6	7	8	9	
0	5 ms	D	S	U	U	U	D	S	U	U	U	61.4%
1	5 ms	D	S	U	U	D	D	S	U	U	D	41.4%
2	5 ms	D	S	U	D	D	D	S	U	D	D	21.4%
3	10 ms	D	S	U	U	U	D	D	D	D	D	30.7%
4	10 ms	D	S	U	U	D	D	D	D	D	D	20.7%
5	10 ms	D	S	U	D	D	D	D	D	D	D	10.7%
6	5 ms	D	S	U	U	U	D	S	U	U	D	51.4%

II. Power Class 3 Uplink-Downlink Configuration Additional Testing

LTE TDD was evaluated with the following radio configuration: channel 40620, 20MHz BW, QPSK, 1RB, 0RB Offset. For Power Class 3, all configurations (0-6) are supported. The configuration which resulted in the worst-case emission was used for full testing. See Table 10-2 below for results. The configuration determined in the results below was used to measure the MIF values in Table 7-5 and Table 7-7.

Table 10-2
LTE TDD Power Class 3 UL-DL Configuration Results

Mode / Band	Bandwidth (MHz)	Channel	UL-DL Config.	Mod.	RB Size	RB Offset	Scan Center	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions															
LTE TDD / Band 41	20	40620	0	QPSK	1	0	Acoustic	7.23	17.18	-3.24	13.94	**35.00**	-21.06	**M4**	1,4,7
	20	40620	1	QPSK	1	0	Acoustic	5.79	15.25	-1.59	13.66	**35.00**	-21.34	**M4**	1,4,7
	20	40620	2	QPSK	1	0	Acoustic	4.43	12.92	1.42	14.34	**35.00**	-20.66	**M4**	1,4,7
	20	40620	3	QPSK	1	0	Acoustic	5.15	14.24	-1.51	12.73	**35.00**	-22.27	**M4**	1,4,7
	20	40620	4	QPSK	1	0	Acoustic	4.51	13.07	0.57	13.64	**35.00**	-21.36	**M4**	1,4,7
	20	40620	5	QPSK	1	0	Acoustic	3.61	11.14	3.60	14.74	**35.00**	-20.26	**M4**	1,4,7
	20	40620	6	QPSK	1	0	Acoustic	6.51	16.27	-2.58	13.69	**35.00**	-21.31	**M4**	1,4,7

III. Power Class 2 Uplink-Downlink Configuration Additional Testing

LTE TDD was evaluated with the following radio configuration: channel 40620, 20MHz BW, QPSK, 1RB, 0RB Offset. For Power Class 2, only configurations 1-5 are supported. The configuration which resulted in the worst-case emission was used for full testing. See Table 10-3 below for results. The configuration determined in the results below was used to measure the MIF values in Table 7-6.

Table 10-3
LTE TDD Power Class 2 UL-DL Configuration Results

Mode / Band	Bandwidth (MHz)	Channel	UL-DL Config.	Mod.	RB Size	RB Offset	Scan Center	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions															
LTE TDD / Band 41	20	40620	1	QPSK	1	0	Acoustic	6.70	16.52	-1.62	14.90	**35.00**	-20.10	**M4**	1,4,7
	20	40620	2	QPSK	1	0	Acoustic	5.05	14.07	1.43	15.50	**35.00**	-19.50	**M4**	1,4,7
	20	40620	3	QPSK	1	0	Acoustic	5.29	14.46	-1.51	12.95	**35.00**	-22.05	**M4**	1,4,7
	20	40620	4	QPSK	1	0	Acoustic	4.53	13.11	0.58	13.69	**35.00**	-21.31	**M4**	1,4,7
	20	40620	5	QPSK	1	0	Acoustic	3.99	12.02	3.66	15.68	**35.00**	-19.32	**M4**	1,4,7

IV. Conclusion

Per the results above, UL-DL Configuration 5 was used for both LTE TDD Power Class 3 and LTE TDD Power Class 2 testing.

11. OVERALL MEASUREMENT SUMMARY

FCC ID:	A3LSMS918U
S/N:	1518M, 0215M

I. E-FIELD EMISSIONS:

Table 11-1
HAC Data Summary for GSM E-field

Mode	Channel	Device SN	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions												
GSM850	128	1518M	Acoustic	31.87	25.33	28.07	3.57	31.64	**45.00**	-13.36	**M4**	2,3,6
	190	1518M	Acoustic	31.52	24.61	27.82	3.57	31.39	**45.00**	-13.61	**M4**	1,2,3
	251	1518M	Acoustic	31.82	23.96	27.59	3.57	31.16	**45.00**	-13.84	**M4**	1,2,3
GSM1900	512	1518M	Acoustic	28.55	7.93	17.99	3.58	21.57	**35.00**	-13.43	**M4**	7,8,9
	661	1518M	Acoustic	28.75	9.72	19.75	3.58	23.33	**35.00**	-11.67	**M4**	6,8,9
	810	1518M	Acoustic	28.86	8.10	18.17	3.58	21.75	**35.00**	-13.25	**M4**	7,8,9

Table 11-2
HAC Data Summary for LTE TDD Band 41 (Power Class 3) E-field – Ant B

Mode / Band	Bandwidth (MHz)	Channel	Device SN	UL-DL Config.	Mod.	RB Size	RB Offset	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions																	
LTE TDD / Band 41 PC3	20	39750	1518M	5	QPSK	1	0	Acoustic	24.02	4.31	12.68	3.81	16.49	**35.00**	-18.51	**M4**	1,2,3
	20	40185	1518M	5	QPSK	1	0	Acoustic	23.93	3.75	11.47	3.83	15.30	**35.00**	-19.70	**M4**	1,4,7
	20	40620	1518M	5	QPSK	1	0	Acoustic	24.05	3.31	10.40	3.78	14.18	**35.00**	-20.82	**M4**	1,4,7
	20	41055	1518M	5	QPSK	1	0	Acoustic	23.85	3.97	11.98	3.79	15.77	**35.00**	-19.23	**M4**	1,2,3
	20	41490	1518M	5	QPSK	1	0	Acoustic	23.85	3.97	11.97	3.79	15.76	**35.00**	-19.24	**M4**	2,3,6

Table 11-3
HAC Data Summary for LTE TDD Band 41 (Power Class 3) E-field – Ant F

Mode / Band	Bandwidth (MHz)	Channel	Device SN	UL-DL Config.	Mod.	RB Size	RB Offset	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions																	
LTE TDD / Band 41 PC3	20	39750	1518M	5	QPSK	1	0	Acoustic	23.77	23.80	27.53	3.81	31.34	**35.00**	-3.66	**M3**	2,3,6
	20	40185	1518M	5	QPSK	1	0	Acoustic	23.70	22.73	27.13	3.83	30.96	**35.00**	-4.04	**M3**	2,3,6
	20	40620	1518M	5	QPSK	1	0	Acoustic	23.65	21.49	26.64	3.78	30.42	**35.00**	-4.58	**M3**	2,3,6
	20	41055	1518M	5	QPSK	1	0	Acoustic	23.68	20.68	26.31	3.79	30.10	**35.00**	-4.90	**M3**	2,3,6
	20	41490	1518M	5	QPSK	1	0	Acoustic	23.59	19.62	25.85	3.79	29.64	**35.00**	-5.36	**M4**	2,3,6

Table 11-4
HAC Data Summary for LTE TDD Band 41 (Power Class 2) E-field – Ant B

Mode / Band	Bandwidth (MHz)	Channel	Device SN	UL-DL Config.	Mod.	RB Size	RB Offset	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions																	
LTE TDD / Band 41 PC2	20	39750	1518M	5	QPSK	1	0	Acoustic	25.85	4.29	12.65	3.84	16.49	**35.00**	-18.51	**M4**	1,4,7
	20	40185	1518M	5	QPSK	1	0	Acoustic	25.81	3.97	11.96	3.85	15.81	**35.00**	-19.19	**M4**	1,4,7
	20	40620	1518M	5	QPSK	1	0	Acoustic	25.98	4.00	12.03	3.83	15.86	**35.00**	-19.14	**M4**	1,4,7
	20	41055	1518M	5	QPSK	1	0	Acoustic	25.48	3.97	11.96	3.85	15.81	**35.00**	-19.19	**M4**	1,4,7
	20	41490	1518M	5	QPSK	1	0	Acoustic	25.94	4.25	12.57	3.85	16.42	**35.00**	-18.58	**M4**	1,4,7

Table 11-5
HAC Data Summary for LTE TDD Band 41 (Power Class 2) E-field – Ant F

Mode / Band	Bandwidth (MHz)	Channel	Sample SN	UL-DL Config.	Mod.	RB Size	RB Offset	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions																	
LTE TDD / Band 41 PC2	20	39750	1518M	5	QPSK	1	0	Acoustic	25.44	28.75	29.17	3.84	33.01	**35.00**	-1.99	**M3**	2,3,6
	20	40185	1518M	5	QPSK	1	0	Acoustic	25.39	27.02	28.63	3.85	32.48	**35.00**	-2.52	**M3**	2,3,6
	20	40620	1518M	5	QPSK	1	0	Acoustic	25.25	26.01	28.30	3.83	32.13	**35.00**	-2.87	**M3**	2,3,6
	20	41055	1518M	5	QPSK	1	0	Acoustic	25.41	24.50	27.78	3.85	31.63	**35.00**	-3.37	**M3**	2,3,6
	20	41490	1518M	5	QPSK	1	0	Acoustic	25.10	23.64	27.47	3.85	31.32	**35.00**	-3.68	**M3**	2,3,6
	20	39750	1518M	5	QPSK	1	0	T-Coil	25.44	20.07	26.05	3.84	29.89	**35.00**	-5.11	**M4**	6,8,9

Table 11-6
HAC Data Summary for LTE TDD Band 48 E-field

Mode / Band	Bandwidth (MHz)	Channel	Sample SN	UL-DL Config.	Mod.	RB Size	RB Offset	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions																	
LTE TDD / Band 48	20	55340	1518M	5	QPSK	1	0	Acoustic	22.20	11.82	21.45	3.75	25.20	**35.00**	-9.80	**M4**	1,2,4
	20	55665	1518M	5	QPSK	1	0	Acoustic	22.32	11.90	21.51	3.72	25.23	**35.00**	-9.77	**M4**	1,2,4
	20	55990	1518M	5	QPSK	1	0	Acoustic	22.25	11.35	21.10	3.76	24.86	**35.00**	-10.14	**M4**	1,2,4
	20	56315	1518M	5	QPSK	1	0	Acoustic	21.96	12.21	21.73	3.72	25.45	**35.00**	-9.55	**M4**	1,2,4
	20	56640	1518M	5	QPSK	1	0	Acoustic	21.63	11.79	21.43	3.78	25.21	**35.00**	-9.79	**M4**	1,2,4

Table 11-7
HAC Data Summary for NR TDD n41 E-field – Ant F

Mode / Band	Bandwidth (MHz)	Channel	Sample SN	Waveform	Mod.	RB Size	RB Offset	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions																	
NR TDD / n41	70	506202	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	26.45	31.45	29.95	1.42	31.37	**35.00**	-3.63	**M3**	2,3,6
	70	512400	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	25.75	30.25	29.61	1.41	31.02	**35.00**	-3.98	**M3**	2,3,6
	70	518598	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	26.30	31.02	29.83	1.44	31.27	**35.00**	-3.73	**M3**	2,3,6
	70	524802	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	25.25	35.56	31.02	1.41	32.43	**35.00**	-2.57	**M3**	2,3,6
	70	531000	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	26.03	36.25	31.19	1.40	32.59	**35.00**	-2.41	**M3**	2,3,6

Table 11-8
HAC Data Summary for NR TDD n41 E-field – Ant B

Mode / Band	Bandwidth (MHz)	Channel	Sample SN	Waveform	Mod.	RB Size	RB Offset	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions																	
NR TDD / n41	70	506202	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	26.12	5.86	15.36	1.42	16.78	**35.00**	-18.22	**M4**	6,8,9
	70	512400	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	25.78	4.57	13.20	1.41	14.61	**35.00**	-20.39	**M4**	1,2,3
	70	518598	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	25.93	5.19	14.30	1.44	15.74	**35.00**	-19.26	**M4**	2,3,6
	70	524802	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	26.04	5.47	14.75	1.41	16.16	**35.00**	-18.84	**M4**	2,3,6
	70	531000	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	26.32	3.81	11.61	1.40	13.01	**35.00**	-21.99	**M4**	1,4,7

Table 11-9
HAC Data Summary for NR TDD n77 DoD E-field

Mode / Band	Bandwidth (MHz)	Channel	Sample SN	Waveform	Mod.	RB Size	RB Offset	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions																	
NR TDD / n77 (DoD)	100	633334	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	26.04	24.47	27.77	1.39	29.16	**35.00**	-5.84	**M4**	1,2,4

Table 11-10
HAC Data Summary for NR TDD n48 E-field

Mode / Band	Bandwidth (MHz)	Channel	Sample SN	Waveform	Mod.	RB Size	RB Offset	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions																	
NR TDD / n48	20	637334	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	22.62	16.54	24.37	1.40	25.77	**35.00**	-9.23	**M4**	1,2,4
	20	639500	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	22.26	16.70	24.45	1.40	25.85	**35.00**	-9.15	**M4**	1,2,4
	20	641666	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	21.75	16.43	24.31	1.42	25.73	**35.00**	-9.27	**M4**	1,2,4
	20	643834	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	21.99	15.76	23.95	1.40	25.35	**35.00**	-9.65	**M4**	1,2,4
	20	646000	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	22.05	16.49	24.34	1.40	25.74	**35.00**	-9.26	**M4**	1,2,4

Table 11-11
HAC Data Summary for NR TDD n77 E-field

Mode / Band	Bandwidth (MHz)	Channel	Sample SN	Waveform	Mod.	RB Size	RB Offset	Scan Center	Conducted Power at BS (dBm)	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
E-Field Emissions																	
NR TDD / n77	100	650000	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	25.77	24.93	27.93	1.39	29.32	**35.00**	-5.68	**M4**	1,2,4
	100	653000	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	26.30	23.21	27.31	1.42	28.73	**35.00**	-6.27	**M4**	1,2,4
	100	656000	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	26.18	22.34	26.98	1.41	28.39	**35.00**	-6.61	**M4**	1,2,4
	100	659000	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	25.89	21.94	26.82	1.42	28.24	**35.00**	-6.76	**M4**	1,2,4
	100	662000	0215M	DFT-s-OFDM	π/2-BPSK	1	1	Acoustic	26.10	20.21	26.11	1.42	27.53	**35.00**	-7.47	**M4**	1,2,4

II. Worst-case Configuration Evaluation

Table 11-12
Peak Reading 360° Probe Rotation at Azimuth axis

Mode	Bandwidth (MHz)	Channel	UL-DL Config.	Mod.	RB Size	RB Offset	Scan Center	Time Avg. Field (V/m)	Time Avg. Field [dB(V/m)]	MIF (dB)	Audio Interference Level [dB(V/m)]	FCC Limit (dBV/m)	FCC Margin (dB)	Result	Excl Blocks per 5.5
Probe Rotation at Worst-Case															
LTE TDD / Band 41 PC2	20	39750	5	QPSK	1	0	Acoustic	29.09	29.27	3.84	33.11	**35.00**	-1.89	**M3**	2,3,6

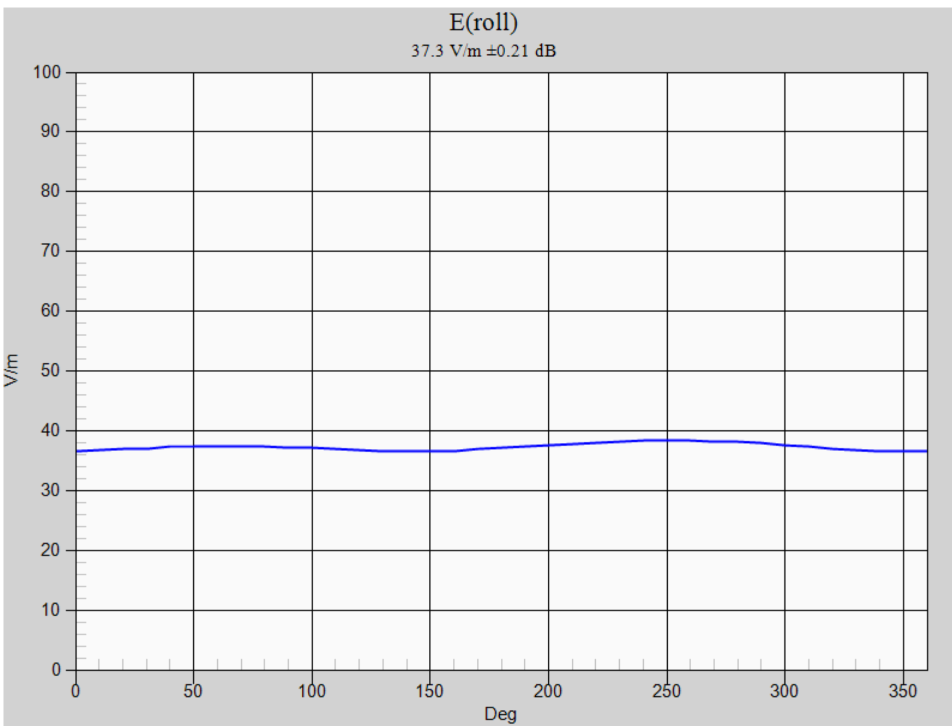


Figure 11-1
Worst-Case Probe Rotation about Azimuth axis

* Note: Locations of probe rotation (with and without exclusions) are shown in Figure 11-2 denoted by the green square markers.

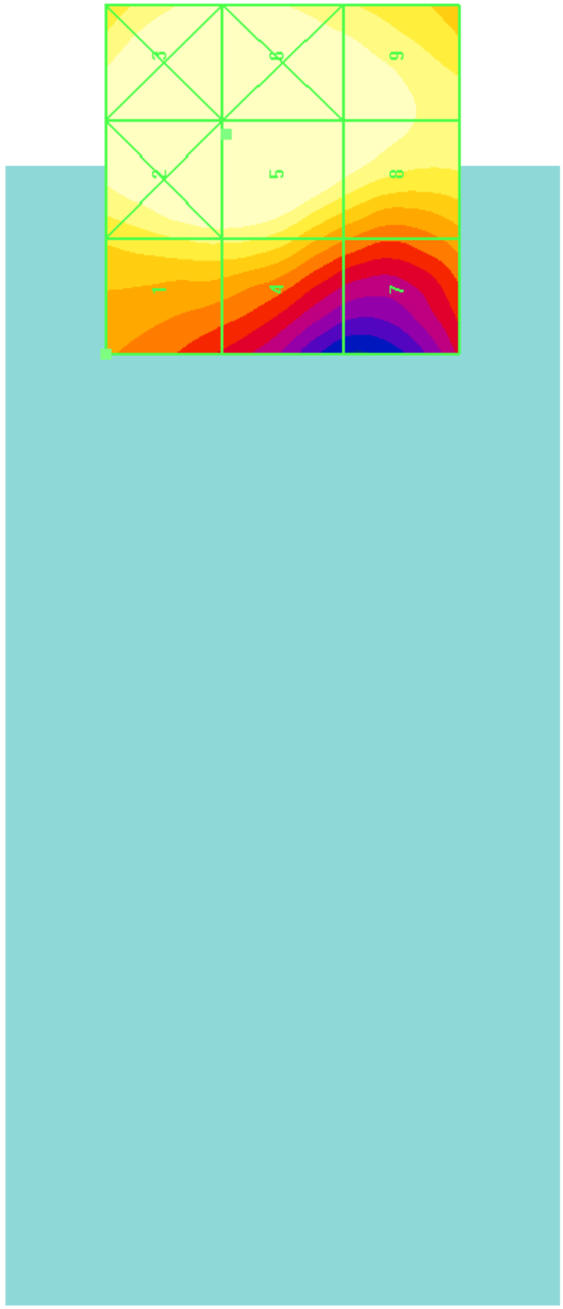


Figure 11-2
Sample E-field Scan Overlay
(See Test Setup Photographs for actual WD overlay.)

12. EQUIPMENT LIST

Table 12-1
Equipment List

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Agilent	E4438C	ESG Vector Signal Generator	11/21/2021	Annual	11/21/2022	MY47270002
Agilent	N5182A	MXG Vector Signal Generator	1/12/2022	Annual	1/12/2023	MY47420837
Keysight Technologies	N9020A	MXA Signal Analyzer	3/15/2022	Annual	3/15/2023	MY54500644
Amplifier Research	15S1G6	Amplifier	N/A	CBT*	N/A	433978
Anritsu	MA2411B	Pulse Power Sensor	11/30/2021	Annual	11/30/2022	1726262
Anritsu	MA2411B	Pulse Power Sensor	12/2/2021	Annual	12/2/2022	1027293
Anritsu	MA24106A	USB Power Sensor	12/3/2021	Annual	12/3/2022	2148504
Anritsu	MA24106A	USB Power Sensor	3/22/2022	Annual	3/22/2023	2205501
Anritsu	ML2496A	Power Meter	3/29/2022	Annual	3/29/2023	1306009
Control Company	4040	Therm./ Clock/ Humidity Monitor	3/12/2021	Biennial	3/12/2023	210202100
Mini-Circuits	NLP-1200+	Low Pass Filter DC to 1000 MHz	N/A	CBT*	N/A	N/A
Mini-Circuits	NLP-2950+	Low Pass Filter DC to 2700 MHz	N/A	CBT*	N/A	N/A
Mini-Circuits	BW-N20W5	Power Attenuator	N/A	CBT*	N/A	1226
Pasternack	PE2237-20	Bidirectional Coupler	N/A	CBT*	N/A	N/A
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	2/17/2022	Annual	2/17/2023	161662
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	4/8/2022	Annual	4/8/2023	162125
Rohde & Schwarz	CMW500	Radio Communication Tester	8/25/2022	Annual	8/25/2023	140144
Rohde & Schwarz	CMX500	Radio Communication Tester	N/A		N/A	100298
Seekonk	NC-100	Torque Wrench (8" lb)	N/A		N/A	21053
SPEAG	AIA	Audio Interference Analzyer	N/A	CBT*	N/A	1010
SPEAG	EF3DV3	Freespace E-field Probe	2/15/2021	Biennial	2/15/2023	4035
SPEAG	CD835V3	Freespace 835 MHz Dipole	1/14/2021	Biennial	1/14/2023	1003
SPEAG	CD1880V3	Freespace 1880 MHz Dipole	1/14/2021	Biennial	1/14/2023	1137
SPEAG	CD2600V3	Freespace 2600MHz Dipole	1/14/2021	Biennial	1/14/2023	1012
SPEAG	CD3500V3	Freespace 3500 MHz Dipole	3/2/2021	Biennial	3/2/2023	1015
SPEAG	DAE4	Dasy Data Acquisition Electronics	12/8/2021	Annual	12/8/2022	1533

Calibration traceable to the National Institute of Standards and Technology (NIST).

***Note: CBT (Calibrated Before Testing).** Prior to testing, the measurement paths containing a cable, attenuator, coupler or filter were connected to a calibrated source (i.e. a signal generator) to determine the losses of the measurement path. The power meter offset was then adjusted to compensate for the measurement system losses. This level offset is stored within the power meter before measurements are made. This calibration verification procedure applies to the system verification and output power measurements. The calibrated reading is then taken directly from the power meter after compensation of the losses for all final power measurements.

13. MEASUREMENT UNCERTAINTY

Table 13-1
Uncertainty Estimation Table

Uncertainty Component	Data (dB)	Data Type	Prob. Dist.	Divisor	Ci (E)	Unc. (dB)	Notes/Comments
Wireless Communications Device Near-Field Measurement Uncertainty Estimation							
Measurement System							
RF System Reflections	0.50	Tolerance	N	1.00	1	0.50	* Refl. < -20 dB
Field Probe Calibration	0.21	Tolerance	N	1.00	1	0.21	
Field Probe Isotropy	0.01	Tolerance	N	1.00	1	0.01	
Field Probe Frequency Response	0.135	Tolerance	N	1.00	1	0.14	
Field Probe Linearity	0.013	Tolerance	N	1.00	1	0.01	
Modulation Interference Factor	0.20	Tolerance	R	1.73	1	0.12	Applicable for M-rating testing
Boundary Effects	0.105	Accuracy	R	1.73	1	0.06	*
Probe Positioning Accuracy	0.20	Accuracy	R	1.73	1	0.12	*
Probe Positioner	0.050	Accuracy	R	1.73	1	0.03	*
Extrapolation/Interpolation	0.045	Tolerance	R	1.73	1	0.03	*
Resolution to 2mm error	0.21	Tolerance	N	1.00	1	0.21	
System Detection Limit	0.05	Tolerance	R	1.73	1	0.03	*
Readout Electronics	0.015	Tolerance	N	1.00	1	0.02	*
Integration Time	0.11	Tolerance	R	1.73	1	0.06	*
Response Time	0.033	Tolerance	R	1.73	1	0.02	*
Phantom Thickness	0.10	Tolerance	R	1.73	1	0.06	*
System Repeatability (Field x 2=power)	0.17	Tolerance	N	1.00	1	0.17	*
Test Sample Related							
Device Positioning Vertical	0.2	Tolerance	R	1.73	1	0.12	*
Device Positioning Lateral	0.045	Tolerance	R	1.73	1	0.03	*
Device Holder and Phantom	0.1	Tolerance	R	1.73	1	0.06	*
Power Drift	0.21	Tolerance	R	1.73	1	0.12	
Combined Standard Uncertainty (k=1)						0.66	16.3%
Expanded Uncertainty [95% confidence]						1.31	32.6%
Expanded Uncertainty [95% confidence] on Field						0.66	16.3%

Notes:
1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.
2. * Uncertainty specifications from Schmidt & Partner Engineering AG (not site specific)

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid immunity tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

14. TEST DATA

See following Attached Pages for Test Data.

Date: 9/26/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: CD835V3 - SN1003

Type: CD835V3
Serial: 1003

Communication System: CW; Frequency: 835 MHz;

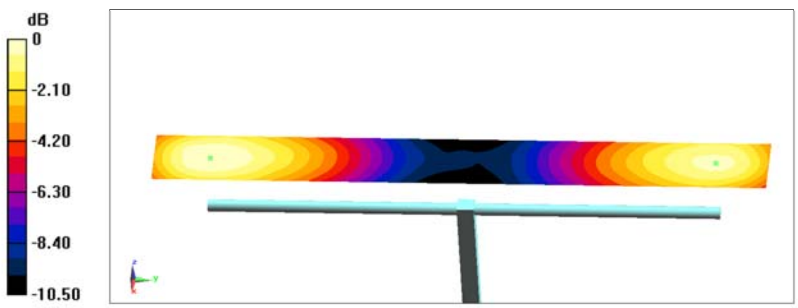
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

835 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x361x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 126.0 V/m; Power Drift = 0.12 dB
Applied MIF = 0.00 dB
Average Value of Peak (interpolated) = 115.2 V/m



0 dB = 118.1 V/m = 41.44 dBV/m

Date: 9/26/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: CD1880V3 - SN1137

Type: CD1880V3
Serial: 1137

Communication System: CW; Frequency: 1880 MHz;

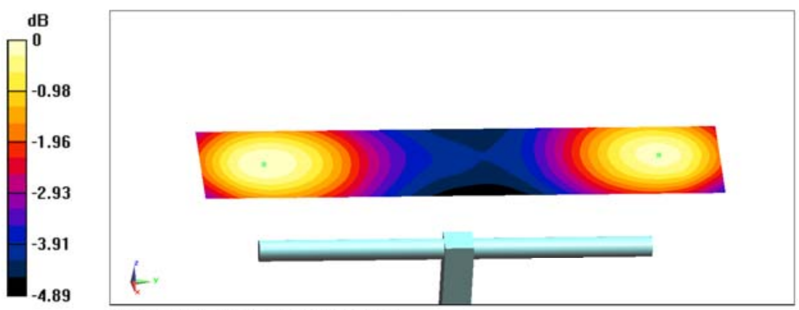
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

1880 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 169.6 V/m; Power Drift = 0.06 dB
Applied MIF = 0.00 dB
Average Value of Peak (interpolated) = 91.7 V/m



0 dB = 92.39 V/m = 39.31 dBV/m

Date: 9/26/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: CD2600V3 - SN1012

Type: CD2600V3
Serial: 1012

Communication System: CW (0); Frequency: 2600 MHz;

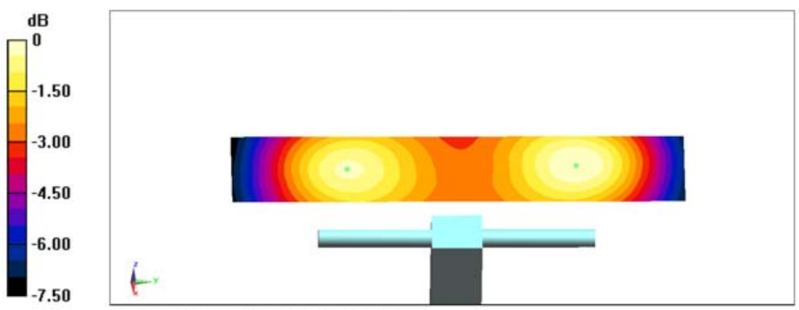
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

2600 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 76.43 V/m; Power Drift = -0.03 dB
Applied MIF = 0.00 dB
Average Value of Peak (interpolated) = 91.6 V/m



0 dB = 93.63 V/m = 39.43 dBV/m

Date: 10/10/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: CD2600V3 - SN1012

Type: CD2600V3
Serial: 1012

Communication System: CW; Frequency: 2600 MHz;

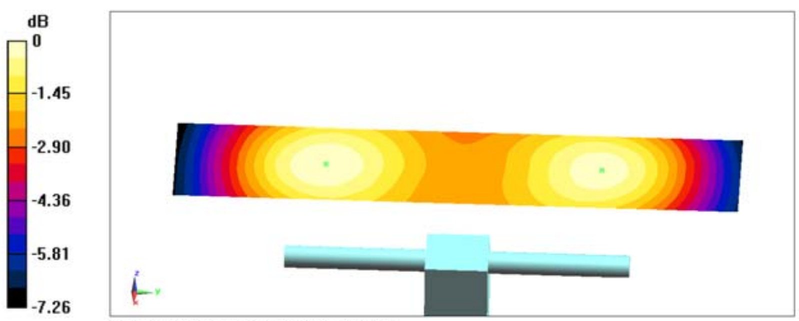
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

2600 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 71.72 V/m; Power Drift = -0.04 dB
Applied MIF = 0.00 dB
Average Value of Peak (interpolated) = 86.4 V/m



0 dB = 87.24 V/m = 38.81 dBV/m

Date: 10/31/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: CD2600V3 - SN1012

Type: CD2600V3
Serial: 1012

Communication System: CW; Frequency: 2600 MHz;

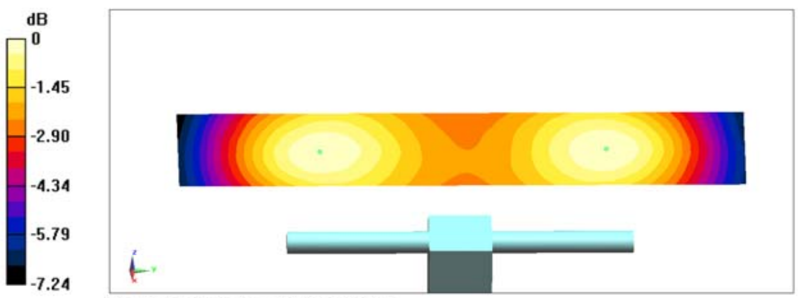
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

2600 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 71.19 V/m; Power Drift = 0.11 dB
Applied MIF = 0.00 dB
Average Value of Peak (interpolated) = 88.4 V/m



0 dB = 88.50 V/m = 38.94 dBV/m

Date: 9/26/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: CD3500V3 - SN1015

Type: CD3500V3
Serial: 1015

Communication System: CW; Frequency: 3500 MHz;

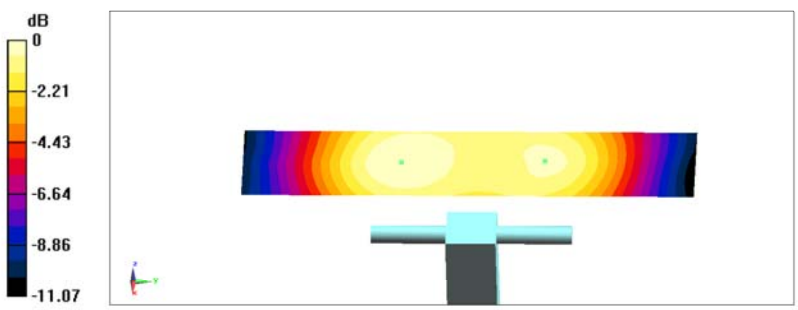
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

3500 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 36.49 V/m; Power Drift = -0.15 dB
Applied MIF = 0.00 dB
Average Value of Peak (interpolated) = 84.8 V/m



0 dB = 87.27 V/m = 38.82 dBV/m

Date: 10/31/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: CD3500V3 - SN1015

Type: CD3500V3
Serial: 1015

Communication System: CW; Frequency: 3500 MHz;

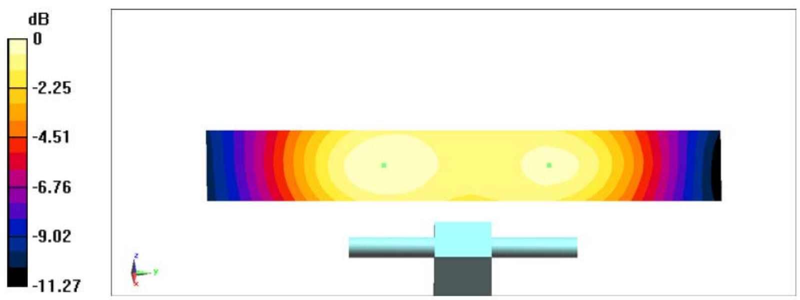
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

3500 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 38.14 V/m; Power Drift = -0.12 dB
Applied MIF = 0.00 dB
Average value of Peak (interpolated) = 84.5 V/m



0 dB = 86.65 V/m = 38.76 dBV/m

PCTEST Hearing-Aid Compatibility Facility

DUT: CD3500V3 - SN1015

Type: CD3500V3
Serial: 1015

Communication System: CW; Frequency: 3900 MHz;

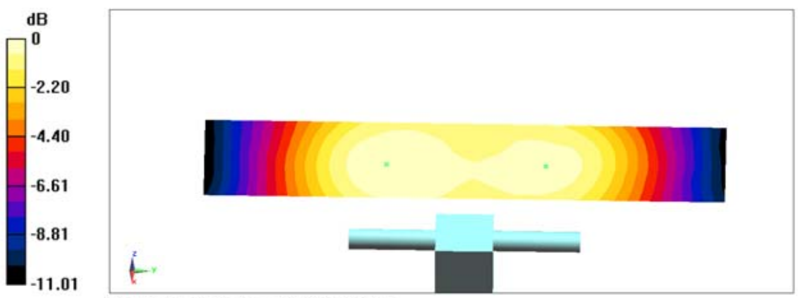
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

3900 MHz / 100mW HAC Dipole Validation at 15mm/Hearing Aid Compatibility Test (41x181x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 37.57 V/m; Power Drift = 0.14 dB
Applied MIF = 0.00 dB
Average Value of Peak (interpolated) = 84.1 V/m



0 dB = 85.64 V/m = 38.65 dBV/m

Date: 9/29/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 1518M
Backlight off
Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 824.2 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

GSM850 Low Channel/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 35.12 V/m; Power Drift = -0.15 dB
Applied MIF = 3.57 dB
RF audio interference level = 31.64 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **31.12 dBV/m**	Grid 2 **M4** **31.95 dBV/m**	Grid 3 **M4** **31.65 dBV/m**
Grid 4 **M4** **30.05 dBV/m**	Grid 5 **M4** **31.64 dBV/m**	Grid 6 **M4** **31.51 dBV/m**
Grid 7 **M4** **28.98 dBV/m**	Grid 8 **M4** **31.16 dBV/m**	Grid 9 **M4** **31.13 dBV/m**

0 dB = 39.28 V/m = 31.88 dBV/m

Date: 9/29/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 1518M
Backlight off
Duty Cycle: 1:8.3

Communication System: GSM; Frequency: 1880 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

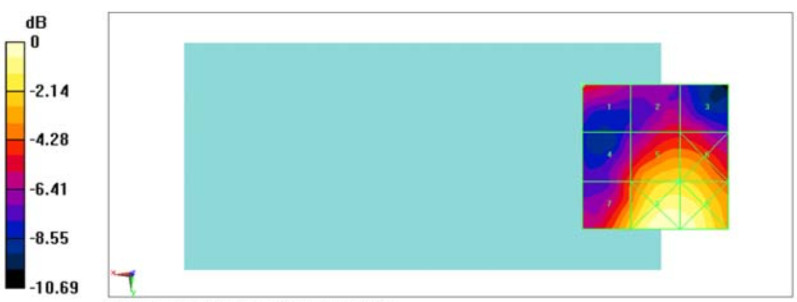
- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

GSM1900 Mid Channel/Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 7.356 V/m; Power Drift = 0.10 dB
Applied MIF = 3.58 dB
RF audio interference level = 23.33 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **20.15 dBV/m**	Grid 2 **M4** **20.15 dBV/m**	Grid 3 **M4** **20.13 dBV/m**
Grid 4 **M4** **20.98 dBV/m**	Grid 5 **M4** **23.33 dBV/m**	Grid 6 **M4** **23.32 dBV/m**
Grid 7 **M4** **23.2 dBV/m**	Grid 8 **M4** **25.46 dBV/m**	Grid 9 **M4** **25.27 dBV/m**



0 dB = 18.58 V/m = 25.38 dBV/m

Date: 9/29/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 1518M
Backlight off
Duty Cycle: 1:9.35

Communication System: LTE TDD41; Frequency: 2506 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

Power Class 3 TDD LTE Band 41, Low Channel, UL-DL 5, QPSK, 20MHz, 1RB, 0RB Offset

Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 4.586 V/m; Power Drift = 0.17 dB
Applied MIF = 3.81 dB
RF audio interference level = 16.49 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **16 dBV/m**	Grid 2 **M4** **15.12 dBV/m**	Grid 3 **M4** **15.49 dBV/m**
Grid 4 **M4** **15.49 dBV/m**	Grid 5 **M4** **16.49 dBV/m**	Grid 6 **M4** **15.53 dBV/m**
Grid 7 **M4** **14.99 dBV/m**	Grid 8 **M4** **15.64 dBV/m**	Grid 9 **M4** **15.73 dBV/m**

0 dB = 5.419 V/m = 14.68 dBV/m

Date: 10/13/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 1518M
Backlight off
Duty Cycle: 1:9.35

Communication System: LTE TDD41; Frequency: 2506 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

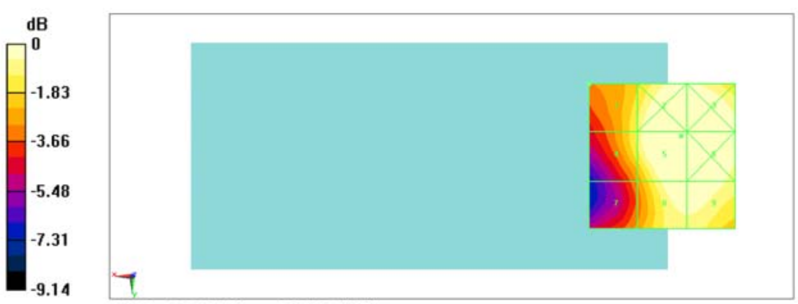
Power Class 3 TDD LTE Band 41 (AntF), Low Channel, UL-DL 5, QPSK, 20MHz, 1RB, 0RB Offset

Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 32.09 V/m; Power Drift = 0.07 dB
Applied MIF = 3.81 dB
RF audio interference level = 31.34 dBV/m
Emission category: M3

MIF scaled E-field

Grid 1 **M4** **28.45 dBV/m**	Grid 2 **M3** **31.32 dBV/m**	Grid 3 **M3** **31.26 dBV/m**
Grid 4 **M4** **28.48 dBV/m**	Grid 5 **M3** **31.34 dBV/m**	Grid 6 **M3** **31.29 dBV/m**
Grid 7 **M4** **26.77 dBV/m**	Grid 8 **M4** **29.96 dBV/m**	Grid 9 **M4** **29.95 dBV/m**



0 dB = 29.95 V/m = 29.53 dBV/m

Date: 9/29/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 1518M
Backlight off
Duty Cycle: 1:9.35

Communication System: LTE TDD41; Frequency: 2506 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

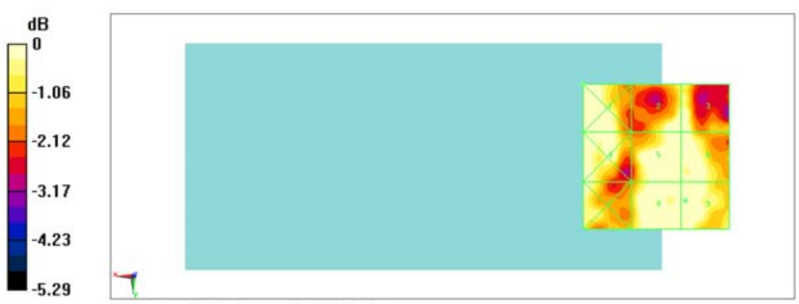
Power Class 2 TDD LTE Band 41, Low Channel, UL-DL 5, QPSK, 20MHz, 1RB, 0RB Offset

Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 4.942 V/m; Power Drift = 0.07 dB
Applied MIF = 3.84 dB
RF audio interference level = 16.49 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **17.03 dBV/m**	Grid 2 **M4** **16.05 dBV/m**	Grid 3 **M4** **16.02 dBV/m**
Grid 4 **M4** **17.39 dBV/m**	Grid 5 **M4** **16.22 dBV/m**	Grid 6 **M4** **16.02 dBV/m**
Grid 7 **M4** **16.26 dBV/m**	Grid 8 **M4** **16.48 dBV/m**	Grid 9 **M4** **16.49 dBV/m**



0 dB = 5.988 V/m = 15.55 dBV/m

Date: 10/13/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 1518M
Backlight off
Duty Cycle: 1:9.35

Communication System: LTE TDD41; Frequency: 2506 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

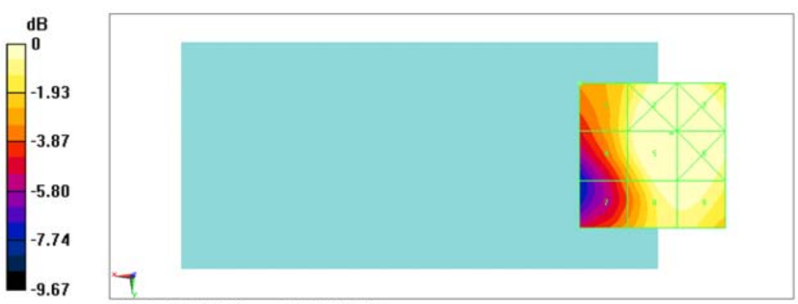
Power Class 2 TDD LTE Band 41 (AntF), Low Channel, UL-DL 5, QPSK, 20MHz, 1RB, 0RB Offset

Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 38.11 V/m; Power Drift = -0.06 dB
Applied MIF = 3.84 dB
RF audio interference level = 33.01 dBV/m
Emission category: M3

MIF scaled E-field

Grid 1 **M3** **30.08 dBV/m**	Grid 2 **M3** **33.01 dBV/m**	Grid 3 **M3** **32.95 dBV/m**
Grid 4 **M3** **30.08 dBV/m**	Grid 5 **M3** **33.01 dBV/m**	Grid 6 **M3** **32.96 dBV/m**
Grid 7 **M4** **28.33 dBV/m**	Grid 8 **M3** **31.51 dBV/m**	Grid 9 **M3** **31.51 dBV/m**



0 dB = 36.18 V/m = 31.17 dBV/m

Date: 9/29/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 1518M
Backlight off
Duty Cycle: 1:9.35

Communication System:LTE Band 48; Frequency: 3657.5 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

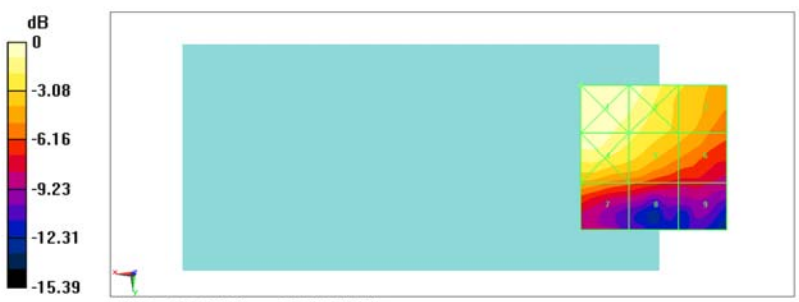
TDD LTE Band 48, Mid High Channel, UL-DL 5, QPSK, 20MHz, 1RB, 0RB Offset

Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 11.80 V/m; Power Drift = -0.05 dB
Applied MIF = 3.72 dB
RF audio interference level = 25.45 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **28.9 dBV/m**	Grid 2 **M4** **27.19 dBV/m**	Grid 3 **M4** **24.44 dBV/m**
Grid 4 **M4** **27 dBV/m**	Grid 5 **M4** **25.45 dBV/m**	Grid 6 **M4** **23.56 dBV/m**
Grid 7 **M4** **22.94 dBV/m**	Grid 8 **M4** **21.45 dBV/m**	Grid 9 **M4** **19.59 dBV/m**



0 dB = 22.87 V/m = 27.19 dBV/m

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 0215M

Backlight off
Duty Cycle: 1:4

Communication System: NR TDD n41; Frequency: 2531.01 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

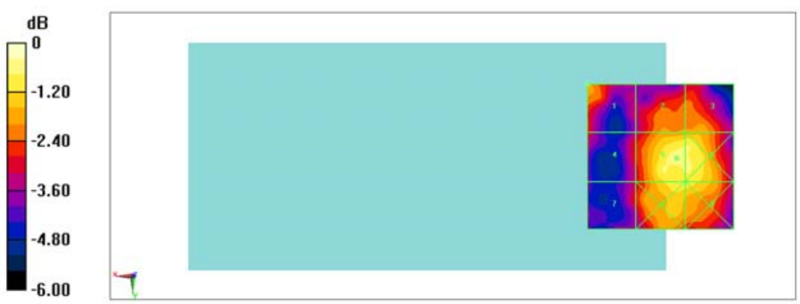
TDD NR Band 41 (AntB), Low Channel, 70MHz BW, DFT-s-OFDM, pi/2-BPSK, 1RB, 1RB Offset

Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 7.320 V/m; Power Drift = -0.13 dB
Applied MIF = 1.42 dB
RF audio interference level = 16.78 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **15.58 dBV/m**	Grid 2 **M4** **15.58 dBV/m**	Grid 3 **M4** **15.72 dBV/m**
Grid 4 **M4** **14.61 dBV/m**	Grid 5 **M4** **16.78 dBV/m**	Grid 6 **M4** **16.66 dBV/m**
Grid 7 **M4** **14.56 dBV/m**	Grid 8 **M4** **16.39 dBV/m**	Grid 9 **M4** **16.37 dBV/m**



0 dB = 7.383 V/m = 17.36 dBV/m

Date: 11/3/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 0215M

Backlight off
Duty Cycle: 1:4

Communication System: NR TDD n41; Frequency: 2655 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

TDD NR Band 41, High Channel, 70MHz BW, DFT-s-OFDM, pi/2-BPSK, 1RB, 1RB Offset

Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 52.55 V/m; Power Drift = 0.20 dB
Applied MIF = 1.40 dB
RF audio interference level = 32.59 dBV/m
Emission category: M3

MIF scaled E-field

Grid 1 **M3** **30.63 dBV/m**	Grid 2 **M3** **32.55 dBV/m**	Grid 3 **M3** **32.37 dBV/m**
Grid 4 **M3** **30.55 dBV/m**	Grid 5 **M3** **32.59 dBV/m**	Grid 6 **M3** **32.39 dBV/m**
Grid 7 **M4** **27.08 dBV/m**	Grid 8 **M3** **30.96 dBV/m**	Grid 9 **M3** **30.93 dBV/m**

0 dB = 45.37 V/m = 33.14 dBV/m

Date: 11/3/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 0215M

Backlight off
Duty Cycle: 1:4

Communication System: NR TDD n77 (DoD); Frequency: 3500 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

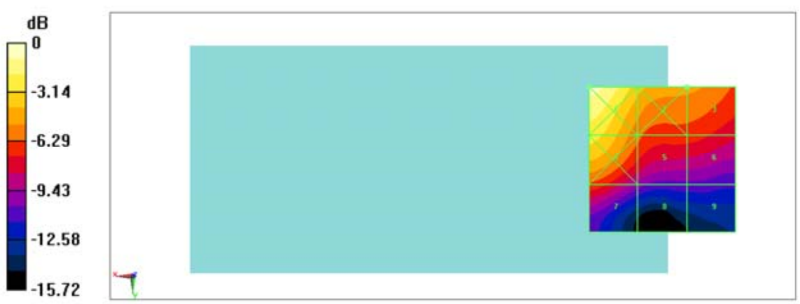
TDD NR Band 77 (DoD), Mid Channel, 100MHz BW, DFT-s-OFDM, pi/2-BPSK, 1RB, 1RB Offset

Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 20.04 V/m; Power Drift = 0.07 dB
Applied MIF = 1.39 dB
RF audio interference level = 29.16 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M3** **33.37 dBV/m**	Grid 2 **M3** **30.38 dBV/m**	Grid 3 **M4** **29.16 dBV/m**
Grid 4 **M3** **31.32 dBV/m**	Grid 5 **M4** **28.09 dBV/m**	Grid 6 **M4** **27.16 dBV/m**
Grid 7 **M4** **27.48 dBV/m**	Grid 8 **M4** **24.19 dBV/m**	Grid 9 **M4** **23.24 dBV/m**



0 dB = 50.00 V/m = 33.98 dBV/m

Date: 11/3/2022

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 0215M
Backlight off
Duty Cycle: 1:4

Communication System: NR TDD n48; Frequency: 3592.5 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

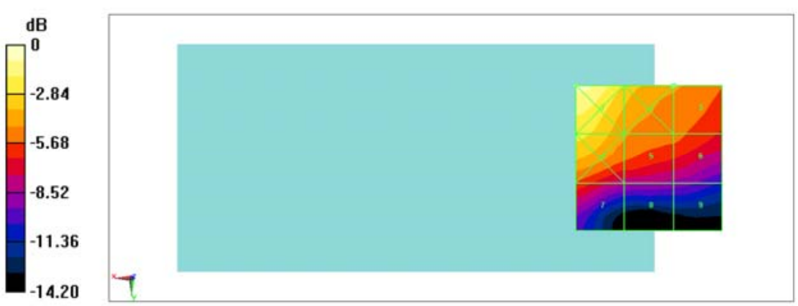
TDD NR Band 48, Low Mid Channel, 20MHz BW, DFT-s-OFDM, pi/2-BPSK, 1RB, 1RB Offset

Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 17.88 V/m; Power Drift = 0.07 dB
Applied MIF = 1.40 dB
RF audio interference level = 25.85 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M4** **29.75 dBV/m**	Grid 2 **M4** **27.44 dBV/m**	Grid 3 **M4** **25.85 dBV/m**
Grid 4 **M4** **27.85 dBV/m**	Grid 5 **M4** **25.85 dBV/m**	Grid 6 **M4** **24.99 dBV/m**
Grid 7 **M4** **24.55 dBV/m**	Grid 8 **M4** **22.19 dBV/m**	Grid 9 **M4** **21.54 dBV/m**



0 dB = 32.94 V/m = 30.35 dBV/m

PCTEST Hearing-Aid Compatibility Facility

DUT: A3LSMS918U

Type: Portable Handset
Serial: 0215M

Backlight off
Duty Cycle: 1:4

Communication System: NR TDD n77; Frequency: 3750 MHz;

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY5 Configuration:

- Probe: EF3DV3 - SN4035; Calibrated: 2/15/2021
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn1533; Calibrated: 12/8/2021
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA;
- Measurement SW: DASY52, Version 52.10 (4);

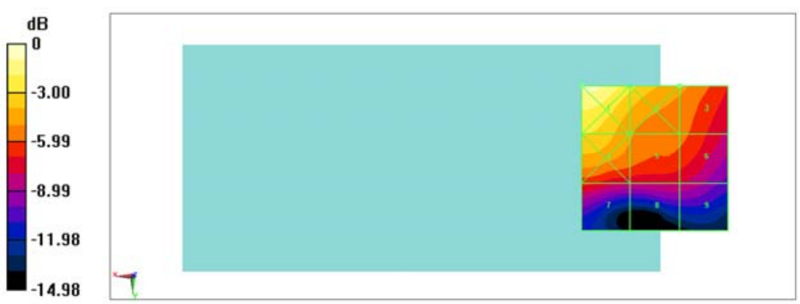
TDD NR Band 77, Low Channel, 100MHz BW, DFT-s-OFDM, pi/2-BPSK, 1RB, 1RB Offset

Hearing Aid Compatibility Test (101x101x1):

Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 25.49 V/m; Power Drift = 0.17 dB
Applied MIF = 1.39 dB
RF audio interference level = 29.32 dBV/m
Emission category: M4

MIF scaled E-field

Grid 1 **M3** **33.31 dBV/m**	Grid 2 **M3** **31.35 dBV/m**	Grid 3 **M4** **29.32 dBV/m**
Grid 4 **M3** **30.91 dBV/m**	Grid 5 **M4** **29.1 dBV/m**	Grid 6 **M4** **28.27 dBV/m**
Grid 7 **M4** **27.3 dBV/m**	Grid 8 **M4** **26.12 dBV/m**	Grid 9 **M4** **25.96 dBV/m**



0 dB = 49.64 V/m = 33.92 dBV/m

15. CALIBRATION CERTIFICATES

The following pages include the probe calibration used to evaluate HAC for the DUT.

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client PC Test

Certificate No: EF3_4035_Feb21

CALIBRATION CERTIFICATE

Object	EF3DV3- SN:4035
Calibration procedure(s)	QA CAL-02.v9, QA CAL-25.v7 Calibration procedure for E-field probes optimized for close near field evaluations in air
Calibration date:	February 15, 2021

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

√TR
2/23/2021

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: CC2552 (20x)	31-Mar-20 (No. 217-03106)	Apr-21
DAE4	SN: 789	23-Dec-20 (No. DAE4-789_Dec20)	Dec-21
Reference Probe ER3DV6	SN: 2328	05-Oct-20 (No. ER3-2328_Oct20)	Oct-21
Secondary Standards	ID	Check Date (in house)	Scheduled Check
Power meter E4419B	SN: GB41293874	06-Apr-16 (in house check Jun-20)	In house check: Jun-22
Power sensor E4412A	SN: MY41498087	06-Apr-16 (in house check Jun-20)	In house check: Jun-22
Power sensor E4412A	SN: 000110210	06-Apr-16 (in house check Jun-20)	In house check: Jun-22
RF generator HP 8648C	SN: US3642U01700	04-Aug-99 (in house check Jun-20)	In house check: Jun-22
Network Analyzer E8358A	SN: US41080477	31-Mar-14 (in house check Oct-20)	In house check: Oct-21

	Name	Function	Signature
Calibrated by:	Michael Weber	Laboratory Technician	M.Weber
Approved by:	Katja Pokovic	Technical Manager	

Issued: February 16, 2021

Glossary:

NORMx,y,z	sensitivity in free space
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
En	incident E-field orientation normal to probe axis
Ep	incident E-field orientation parallel to probe axis
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., ϑ = 0 is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

a) IEEE Std 1309-2005, " IEEE Standard for calibration of electromagnetic field sensors and probes, excluding antennas, from 9 kHz to 40 GHz", December 2005
b) CTIA Test Plan for Hearing Aid Compatibility, Rev 3.1.1, May 2017

Methods Applied and Interpretation of Parameters:

- *NORMx,y,z:* Assessed for E-field polarization ϑ = 0 for XY sensors and ϑ = 90 for Z sensor (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
- *NORM(f)x,y,z = NORMx,y,z * frequency_response* (see Frequency Response Chart).
- *DCPx,y,z:* DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- *PAR:* PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- *Ax,y,z; Bx,y,z; Cx,y,z; Dx,y,z; VRx,y,z: A, B, C, D* are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. *VR* is the maximum calibration range expressed in RMS voltage across the diode.
- *Spherical isotropy (3D deviation from isotropy)*: in a locally homogeneous field realized using an open waveguide setup.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- *Connector Angle*: The angle is assessed using the information gained by determining the *NORMx* (no uncertainty required).

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4035

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm ($\mu V/(V/m)^2$)	0.90	0.73	1.19	± 10.1 %
DCP (mV)[B]	96.3	101.2	98.2	

Calibration results for Frequency Response (30 MHz – 6 GHz)

Frequency MHz	Target E-Field V/m	Measured E-field (En) V/m	Deviation E-normal in %	Measured E-field (Ep) V/m	Deviation E-normal in %	Unc (k=2) %
30	77.1	77.0	-0.2%	77.2	0.1%	± 5.1 %
100	77.2	78.3	1.4%	77.8	0.7%	± 5.1 %
450	77.2	78.4	1.6%	77.9	1.0%	± 5.1 %
600	77.1	77.9	1.1%	77.4	0.5%	± 5.1 %
750	77.1	77.8	0.9%	77.3	0.3%	± 5.1 %
1800	143.1	139.0	-2.8%	139.4	-2.6%	± 5.1 %
2000	135.1	131.3	-2.7%	131.5	-2.6%	± 5.1 %
2200	127.7	123.4	-3.3%	124.5	-2.5%	± 5.1 %
2500	125.5	122.4	-2.5%	123.5	-1.6%	± 5.1 %
3000	79.4	75.6	-4.7%	76.7	-3.3%	± 5.1 %
3500	256.9	246.8	-3.9%	243.9	-4.8%	± 5.1 %
3700	251.2	240.8	-4.2%	237.9	-5.0%	± 5.1 %
5200	50.8	51.4	1.3%	51.7	1.9%	± 5.1 %
5500	47.0	46.8	-0.5%	48.2	2.7%	± 5.1 %
5800	48.8	48.6	-0.6%	47.1	-3.6%	± 5.1 %

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB$\sqrt{\mu V}$	C	D dB	VR mV	Max dev.	Unc[E] (k=2)
0	CW	X	0.0	0.0	1.0	0.00	141.8	± 3.8 %	± 4.7 %
		Y	0.0	0.0	1.0		172.6		
		Z	0.0	0.0	1.0		171.7		

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

[B] Numerical linearization parameter: uncertainty not required.
[E] Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

DASY/EASY - Parameters of Probe: EF3DV3 - SN:4035

Sensor Frequency Model Parameters

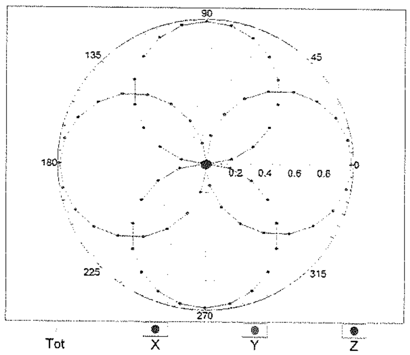
	Sensor X	Sensor Y	Sensor Z
Frequency Corr. (LF)	0.22	0.19	5.72
Frequency Corr. (HF)	2.82	2.82	2.82

Other Probe Parameters

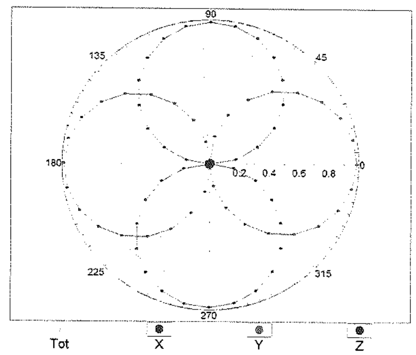
Sensor Arrangement	Rectangular
Connector Angle (°)	-126.8
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	12 mm
Tip Length	25 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	1.5 mm
Probe Tip to Sensor Y Calibration Point	1.5 mm
Probe Tip to Sensor Z Calibration Point	1.5 mm

Receiving Pattern (ϕ), $\vartheta = 0°$

f=600 MHz,TEM,0°

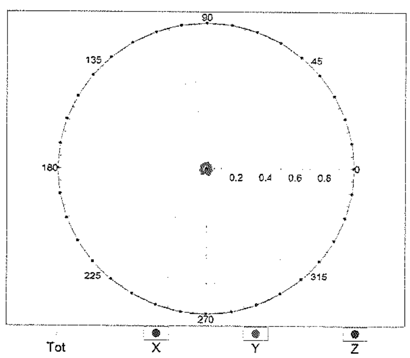


f=1800 MHz,R22,0°

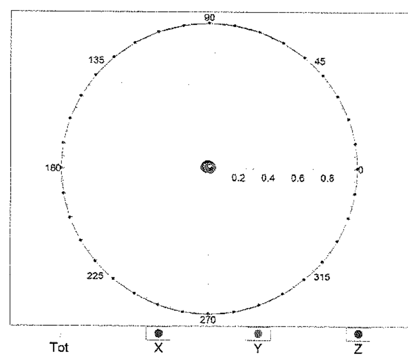


Receiving Pattern (ϕ), $\vartheta = 90°$

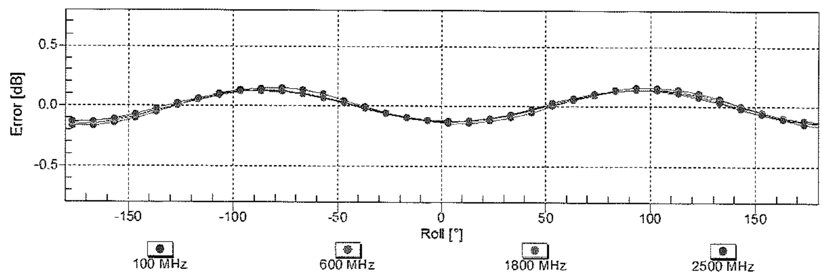
f=600 MHz,TEM,90°



f=1800 MHz,R22,90°

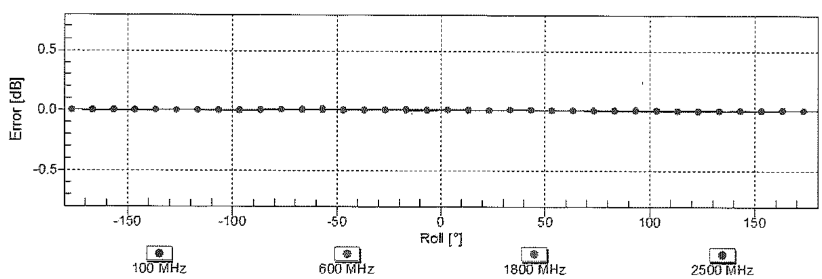


Receiving Pattern (ϕ), ϑ = 0°



Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

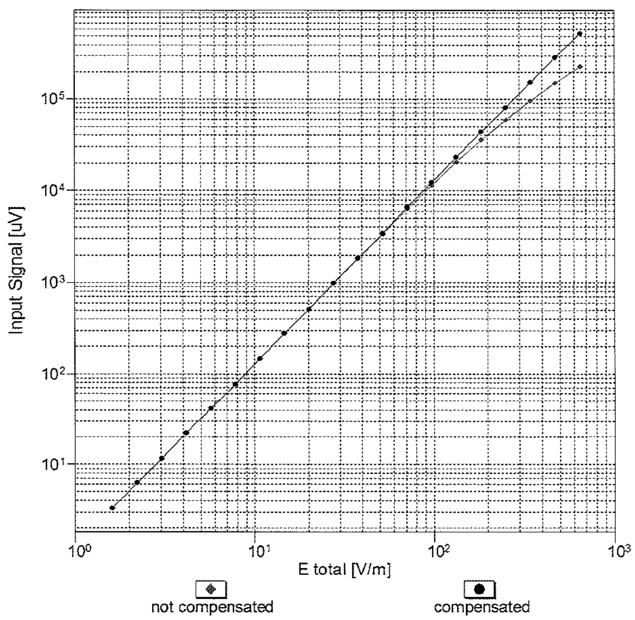
Receiving Pattern (ϕ), ϑ = 90°

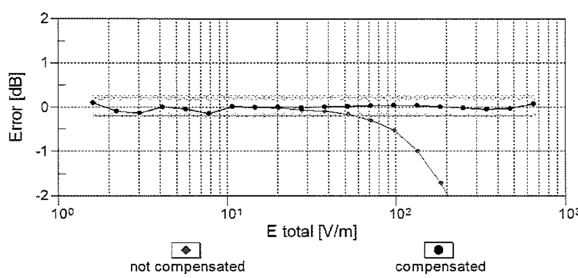


Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Dynamic Range f(E-field)

(TEM cell, f = 900 MHz)

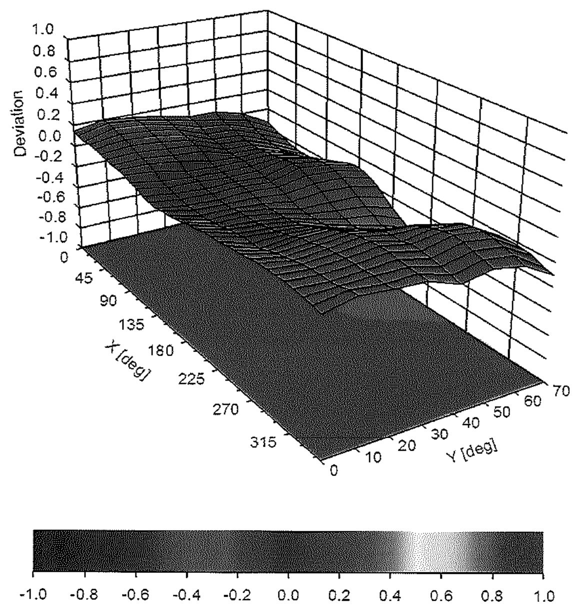




Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Deviation from Isotropy in Air

Error (ϕ, ϑ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client PC Test

Certificate No: CD835V3-1003_Jan21

CALIBRATION CERTIFICATE

Object	CD835V3 - SN: 1003
Calibration procedure(s)	QA CAL-20.v7 Calibration Procedure for Validation Sources in air
Calibration date:	January 14, 2021

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

✓ a4 3/30/2021

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: BH9394 (20k)	31-Mar-20 (No. 217-03106)	Apr-21
Type-N mismatch combination	SN: 310982 / 06327	31-Mar-20 (No. 217-03104)	Apr-21
Probe EF3DV3	SN: 4013	28-Dec-20 (No. EF3-4013_Dec20)	Dec-21
DAE4	SN: 781	23-Dec-20 (No. DAE4-781_Dec20)	Dec-21

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-20)	In house check: Oct-23
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-20)	In house check: Oct-23
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-20)	In house check: Oct-23
RF generator R&S SMT-06	SN: 837633/005	10-Jan-19 (in house check Oct-20)	In house check: Oct-23
Network Analyzer Agilent E8358A	SN: US41080477	31-Mar-14 (in house check Oct-20)	In house check: Oct-21

	Name	Function	Signature
Calibrated by:	Leif Klysner	Laboratory Technician	Leif Klysner
Approved by:	Katja Pokovic	Technical Manager	

Issued: January 16, 2021

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

References

[1] ANSI-C63.19-2011
American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- *Coordinate System:* y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- *Measurement Conditions:* Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- *Antenna Positioning:* The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections.
  It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- *Feed Point Impedance and Return Loss:* These parameters are measured using a Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- *E-field distribution:* E field is measured in the x-y-plane with an isotropic E-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.4
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	835 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 835 MHz

E-field 15 mm above dipole surface	condition	**Interpolated maximum**
Maximum measured above high end	100 mW input power	109.9 V/m = 40.82 dBV/m
Maximum measured above low end	100 mW input power	106.8 V/m = 40.57 dBV/m
Averaged maximum above arm	100 mW input power	**108.4 V/m ± 12.8 % (k=2)**

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

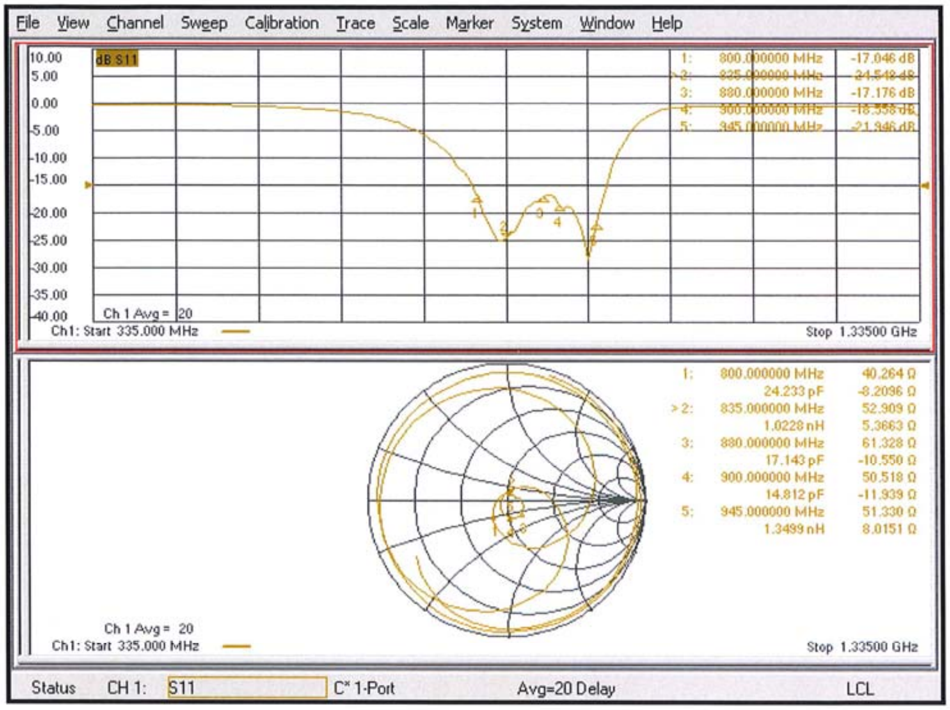
Frequency	**Return Loss**	**Impedance**
800 MHz	17.0 dB	40.3 Ω - 8.2 jΩ
835 MHz	24.5 dB	52.9 Ω + 5.4 jΩ
880 MHz	17.2 dB	61.3 Ω - 10.6 jΩ
900 MHz	18.6 dB	50.5 Ω - 11.9 jΩ
945 MHz	21.9 dB	51.3 Ω + 8.0 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Impedance Measurement Plot



Certificate No: CD835V3-1003_Jan21 Page 4 of 5

DASY5 E-field Result

Date: 14.01.2021

Test Laboratory: SPEAG Lab2

DUT: HAC-Dipole 835 MHz; Type: CD835V3; Serial: CD835V3 - SN: 1003

Communication System: UID 0 - CW ; Frequency: 835 MHz
Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m^3
Phantom section: RF Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

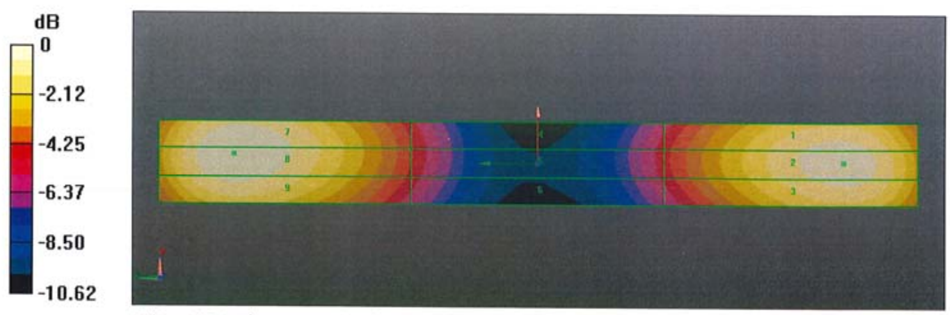
DASY52 Configuration:

- Probe: EF3DV3 - SN4013; ConvF(1, 1, 1) @ 835 MHz; Calibrated: 28.12.2020
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 23.12.2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.4(1527); SEMCAD X 14.6.14(7483)

Dipole E-Field measurement @ 835MHz/E-Scan - 835MHz d=15mm/Hearing Aid Compatibility Test (41x361x1):
Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 132.2 V/m; Power Drift = 0.03 dB
Applied MIF = 0.00 dB
RF audio interference level = 40.82 dBV/m
Emission category: M3

MIF scaled E-field

Grid 1 **M3** **40.45 dBV/m**	Grid 2 **M3** **40.57 dBV/m**	Grid 3 **M3** **40.35 dBV/m**
Grid 4 **M4** **35.95 dBV/m**	Grid 5 **M4** **35.96 dBV/m**	Grid 6 **M4** **35.61 dBV/m**
Grid 7 **M3** **40.79 dBV/m**	Grid 8 **M3** **40.82 dBV/m**	Grid 9 **M3** **40.4 dBV/m**



0 dB = 109.9 V/m = 40.82 dBV/m

Calibration Laboratory of
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Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland

S **Schweizerischer Kalibrierdienst**
C **Service suisse d'étalonnage**
S **Servizio svizzero di taratura**
Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client **PC Test**

Certificate No: CD1880V3-1137_Jan21

CALIBRATION CERTIFICATE

Object	CD1880V3 - SN: 1137
Calibration procedure(s)	QA CAL-20.v7 Calibration Procedure for Validation Sources in air
Calibration date:	January 14, 2021

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

√aA
3/30/2021

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: BH9394 (20k)	31-Mar-20 (No. 217-03106)	Apr-21
Type-N mismatch combination	SN: 310982 / 06327	31-Mar-20 (No. 217-03104)	Apr-21
Probe EF3DV3	SN: 4013	28-Dec-20 (No. EF3-4013_Dec20)	Dec-21
DAE4	SN: 781	23-Dec-20 (No. DAE4-781_Dec20)	Dec-21

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-20)	In house check: Oct-23
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-20)	In house check: Oct-23
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-20)	In house check: Oct-23
RF generator R&S SMT-06	SN: 837633/005	10-Jan-19 (in house check Oct-20)	In house check: Oct-23
Network Analyzer Agilent E8358A	SN: US41080477	31-Mar-14 (in house check Oct-20)	In house check: Oct-21

	Name	Function	Signature
Calibrated by:	Leif Klysner	Laboratory Technician	Leif Klysner
Approved by:	Katja Pokovic	Technical Manager	

Issued: January 16, 2021

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

References

[1] ANSI-C63.19-2011
American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- *Coordinate System:* y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- *Measurement Conditions:* Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- *Antenna Positioning:* The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections.
It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- *Feed Point Impedance and Return Loss:* These parameters are measured using a Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- *E-field distribution:* E field is measured in the x-y-plane with an isotropic E-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.4
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	1730 MHz ± 1 MHz 1880 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 1730 MHz

E-field 15 mm above dipole surface	condition	**Interpolated maximum**
Maximum measured above high end	100 mW input power	94.2 V/m = 39.48 dBV/m
Maximum measured above low end	100 mW input power	93.8 V/m = 39.44 dBV/m
Averaged maximum above arm	100 mW input power	**94.0 V/m ± 12.8 % (k=2)**

Maximum Field values at 1880 MHz

E-field 15 mm above dipole surface	condition	**Interpolated maximum**
Maximum measured above high end	100 mW input power	88.0 V/m = 38.89 dBV/m
Maximum measured above low end	100 mW input power	87.8 V/m = 38.87 dBV/m
Averaged maximum above arm	100 mW input power	**87.9 V/m ± 12.8 % (k=2)**

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Nominal Frequencies

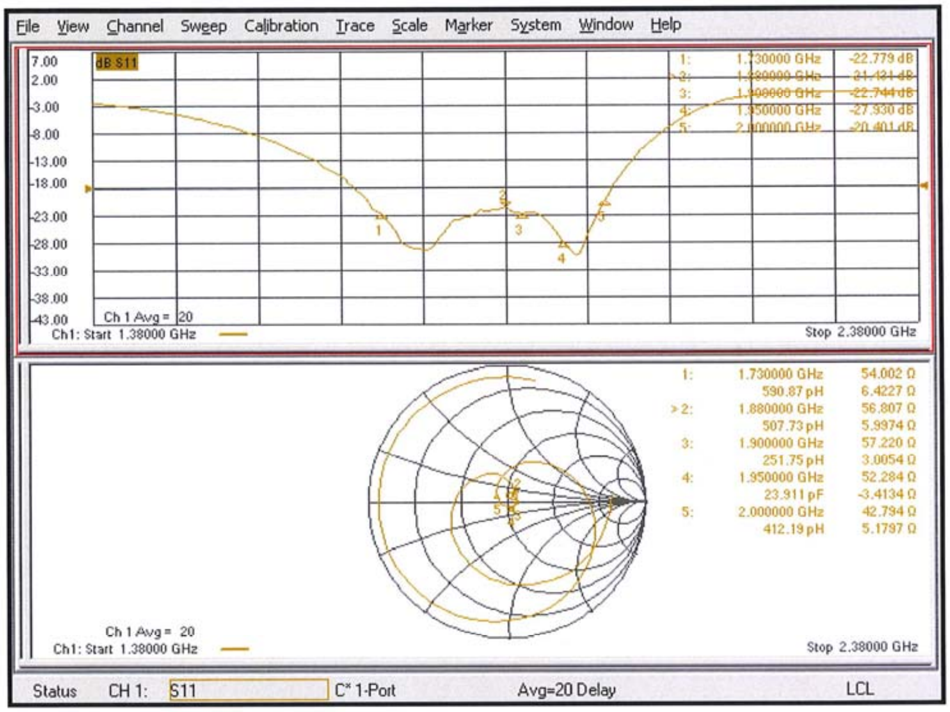
Frequency	Return Loss	Impedance
1730 MHz	22.8 dB	54.0 Ω + 6.4 jΩ
1880 MHz	21.4 dB	56.8 Ω + 6.0 jΩ
1900 MHz	22.7 dB	57.2 Ω + 3.0 jΩ
1950 MHz	27.9 dB	52.3 Ω - 3.4 jΩ
2000 MHz	20.4 dB	42.8 Ω + 5.2 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Impedance Measurement Plot



Certificate No: CD1880V3-1137_Jan21 Page 5 of 7

DASY5 E-field Result

Date: 14.01.2021

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 1880 MHz; Type: CD1880V3; Serial: CD1880V3 - SN: 1137

Communication System: UID 0 - CW ; Frequency: 1880 MHz, Frequency: 1730 MHz
Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m^3
Phantom section: RF Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EF3DV3 - SN4013; ConvF(1, 1, 1) @ 1880 MHz, ConvF(1, 1, 1) @ 1730 MHz; Calibrated: 28.12.2020
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 23.12.2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.4(1527); SEMCAD X 14.6.14(7483)

Dipole E-Field measurement @ 1880MHz/E-Scan - 1880MHz d=15mm/Hearing Aid Compatibility Test (41x181x1):
Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 157.0 V/m; Power Drift = 0.02 dB
Applied MIF = 0.00 dB
RF audio interference level = 38.89 dBV/m
Emission category: M2

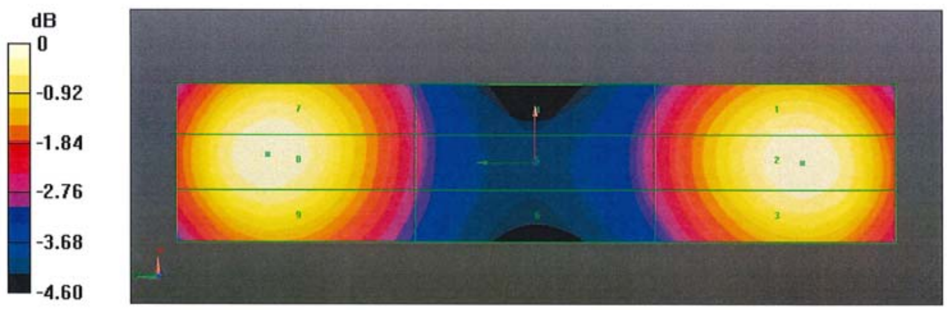
MIF scaled E-field

Grid 1 **M2** **38.7 dBV/m**	Grid 2 **M2** **38.87 dBV/m**	Grid 3 **M2** **38.68 dBV/m**
Grid 4 **M2** **36.04 dBV/m**	Grid 5 **M2** **36.09 dBV/m**	Grid 6 **M2** **35.98 dBV/m**
Grid 7 **M2** **38.81 dBV/m**	Grid 8 **M2** **38.89 dBV/m**	Grid 9 **M2** **38.56 dBV/m**

Dipole E-Field measurement @ 1880MHz/E-Scan - 1730MHz d=15mm/Hearing Aid Compatibility Test (41x181x1):
Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 169.8 V/m; Power Drift = 0.01 dB
Applied MIF = 0.00 dB
RF audio interference level = 39.48 dBV/m
Emission category: M2

MIF scaled E-field

Grid 1 **M2** 39.27 dBV/m	Grid 2 **M2** 39.44 dBV/m	Grid 3 **M2** 39.24 dBV/m
Grid 4 **M2** 36.67 dBV/m	Grid 5 **M2** 36.74 dBV/m	Grid 6 **M2** 36.58 dBV/m
Grid 7 **M2** 39.39 dBV/m	Grid 8 **M2** 39.48 dBV/m	Grid 9 **M2** 39.13 dBV/m



0 dB = 87.99 V/m = 38.89 dBV/m

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S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 0108

Client **PC Test**

Certificate No: CD2600V3-1012_Jan21

CALIBRATION CERTIFICATE

Object	CD2600V3 - SN: 1012
Calibration procedure(s)	QA CAL-20.v7 Calibration Procedure for Validation Sources in air
Calibration date:	January 14, 2021

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

√ at
3/30/2021

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: BH9394 (20k)	31-Mar-20 (No. 217-03106)	Apr-21
Type-N mismatch combination	SN: 310982 / 06327	31-Mar-20 (No. 217-03104)	Apr-21
Probe EF3DV3	SN: 4013	28-Dec-20 (No. EF3-4013_Dec20)	Dec-21
DAE4	SN: 781	23-Dec-20 (No. DAE4-781_Dec20)	Dec-21

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-20)	In house check: Oct-23
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-20)	In house check: Oct-23
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-20)	In house check: Oct-23
RF generator R&S SMT-06	SN: 837633/005	10-Jan-19 (in house check Oct-20)	In house check: Oct-23
Network Analyzer Agilent E8358A	SN: US41080477	31-Mar-14 (in house check Oct-20)	In house check: Oct-21

	Name	Function	Signature
Calibrated by:	Leif Klysner	Laboratory Technician	Leif Klysner
Approved by:	Katja Pokovic	Technical Manager	

Issued: January 16, 2021

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

References

[1] ANSI-C63.19-2011
American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- *Coordinate System:* y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- *Measurement Conditions:* Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- *Antenna Positioning:* The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections.
It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- *Feed Point Impedance and Return Loss:* These parameters are measured using a Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- *E-field distribution:* E field is measured in the x-y-plane with an isotropic E-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.4
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	2600 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 2600 MHz

E-field 15 mm above dipole surface	condition	**Interpolated maximum**
Maximum measured above high end	100 mW input power	86.8 V/m = 38.77 dBV/m
Maximum measured above low end	100 mW input power	86.3 V/m = 38.72 dBV/m
Averaged maximum above arm	100 mW input power	**86.5 V/m ± 12.8 % (k=2)**

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

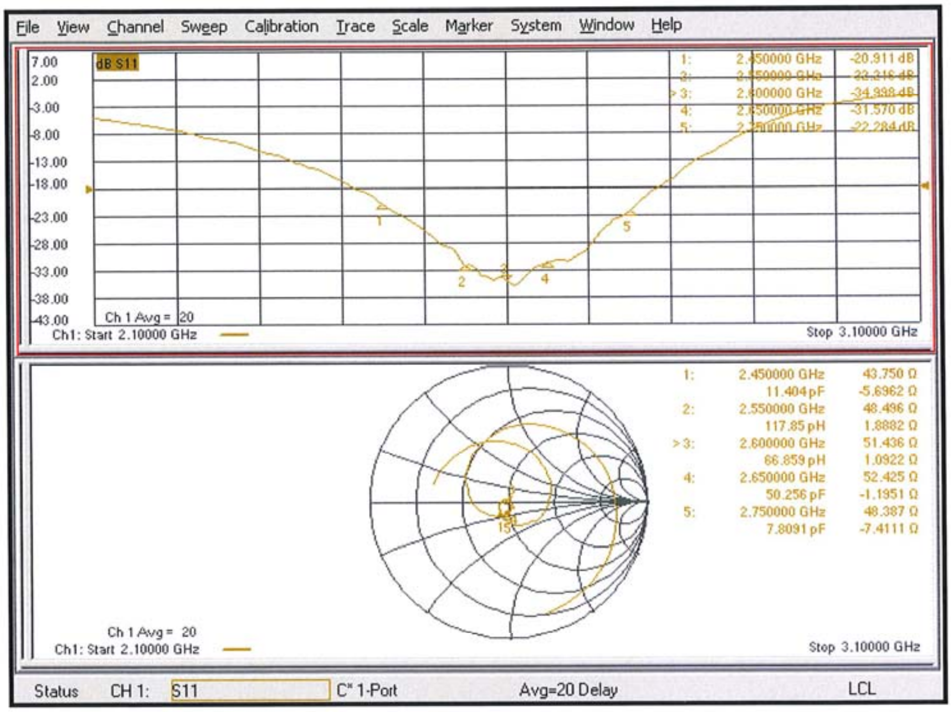
Frequency	**Return Loss**	**Impedance**
2450 MHz	20.9 dB	43.7 Ω - 5.7 jΩ
2550 MHz	32.2 dB	48.5 Ω + 1.9 jΩ
2600 MHz	35.0 dB	51.4 Ω + 1.1 jΩ
2650 MHz	31.6 dB	52.4 Ω - 1.2 jΩ
2750 MHz	22.3 dB	48.4 Ω - 7.4 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Impedance Measurement Plot



Certificate No: CD2600V3-1012_Jan21 Page 4 of 5

DASY5 E-field Result

Date: 14.01.2021

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 2600 MHz; Type: CD2600V3; Serial: CD2600V3 - SN: 1012

Communication System: UID 0 - CW ; Frequency: 2600 MHz
Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m^3
Phantom section: RF Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

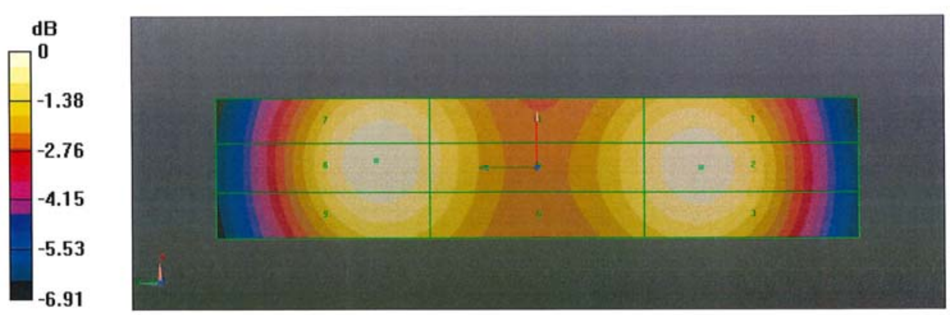
DASY52 Configuration:

- Probe: EF3DV3 - SN4013; ConvF(1, 1, 1) @ 2600 MHz; Calibrated: 28.12.2020
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 23.12.2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.4(1527); SEMCAD X 14.6.14(7483)

Dipole E-Field measurement @ 2600MHz/E-Scan - 2600MHz d=15mm/Hearing Aid Compatibility Test (41x181x1):
Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 67.09 V/m; Power Drift = -0.03 dB
Applied MIF = 0.00 dB
RF audio interference level = 38.77 dBV/m
Emission category: M2

MIF scaled E-field

Grid 1 **M2** **38.56 dBV/m**	Grid 2 **M2** **38.72 dBV/m**	Grid 3 **M2** **38.5 dBV/m**
Grid 4 **M2** **38.08 dBV/m**	Grid 5 **M2** **38.12 dBV/m**	Grid 6 **M2** **37.92 dBV/m**
Grid 7 **M2** **38.69 dBV/m**	Grid 8 **M2** **38.77 dBV/m**	Grid 9 **M2** **38.5 dBV/m**



0 dB = 86.78 V/m = 38.77 dBV/m

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Accreditation No.: **SCS 0108**

Client **PC Test**

Certificate No: **CD3500V3-1015_Mar21**

CALIBRATION CERTIFICATE

Object: CD3500V3 - SN: 1015

Calibration procedure(s): QA CAL-20.v7
Calibration Procedure for Validation Sources in air

Calibration date: March 02, 2021

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

JaA
3/30/2021

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter NRP	SN: 104778	01-Apr-20 (No. 217-03100/03101)	Apr-21
Power sensor NRP-Z91	SN: 103244	01-Apr-20 (No. 217-03100)	Apr-21
Power sensor NRP-Z91	SN: 103245	01-Apr-20 (No. 217-03101)	Apr-21
Reference 20 dB Attenuator	SN: BH9394 (20k)	31-Mar-20 (No. 217-03106)	Apr-21
Type-N mismatch combination	SN: 310982 / 06327	31-Mar-20 (No. 217-03104)	Apr-21
Probe EF3DV3	SN: 4013	28-Dec-20 (No. EF3-4013_Dec20)	Dec-21
DAE4	SN: 781	23-Dec-20 (No. DAE4-781_Dec20)	Dec-21

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power meter Agilent 4419B	SN: GB42420191	09-Oct-09 (in house check Oct-20)	In house check: Oct-23
Power sensor HP E4412A	SN: US38485102	05-Jan-10 (in house check Oct-20)	In house check: Oct-23
Power sensor HP 8482A	SN: US37295597	09-Oct-09 (in house check Oct-20)	In house check: Oct-23
RF generator R&S SMT-06	SN: 837633/005	10-Jan-19 (in house check Oct-20)	In house check: Oct-23
Network Analyzer Agilent E8358A	SN: US41080477	31-Mar-14 (in house check Oct-20)	In house check: Oct-21

	Name	Function	Signature
Calibrated by:	Leif Klysner	Laboratory Technician	Leif Klysner
Approved by:	Katja Pokovic	Technical Manager	

Issued: March 2, 2021

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Accreditation No.: SCS 0108

References

[1] ANSI-C63.19-2011
American National Standard, Methods of Measurement of Compatibility between Wireless Communications Devices and Hearing Aids.

Methods Applied and Interpretation of Parameters:

- *Coordinate System:* y-axis is in the direction of the dipole arms. z-axis is from the basis of the antenna (mounted on the table) towards its feed point between the two dipole arms. x-axis is normal to the other axes. In coincidence with the standards [1], the measurement planes (probe sensor center) are selected to be at a distance of 15 mm above the top metal edge of the dipole arms.
- *Measurement Conditions:* Further details are available from the hardcopies at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated. The forward power to the dipole connector is set with a calibrated power meter connected and monitored with an auxiliary power meter connected to a directional coupler. While the dipole under test is connected, the forward power is adjusted to the same level.
- *Antenna Positioning:* The dipole is mounted on a HAC Test Arch phantom using the matching dipole positioner with the arms horizontal and the feeding cable coming from the floor. The measurements are performed in a shielded room with absorbers around the setup to reduce the reflections.
It is verified before the mounting of the dipole under the Test Arch phantom, that its arms are perfectly in a line. It is installed on the HAC dipole positioner with its arms parallel below the dielectric reference wire and able to move elastically in vertical direction without changing its relative position to the top center of the Test Arch phantom. The vertical distance to the probe is adjusted after dipole mounting with a DASY5 Surface Check job. Before the measurement, the distance between phantom surface and probe tip is verified. The proper measurement distance is selected by choosing the matching section of the HAC Test Arch phantom with the proper device reference point (upper surface of the dipole) and the matching grid reference point (tip of the probe) considering the probe sensor offset. The vertical distance to the probe is essential for the accuracy.
- *Feed Point Impedance and Return Loss:* These parameters are measured using a Vector Network Analyzer. The impedance is specified at the SMA connector of the dipole. The influence of reflections was eliminating by applying the averaging function while moving the dipole in the air, at least 70cm away from any obstacles.
- *E-field distribution:* E field is measured in the x-y-plane with an isotropic E-field probe with 100 mW forward power to the antenna feed point. In accordance with [1], the scan area is 20mm wide, its length exceeds the dipole arm length (180 or 90mm). The sensor center is 15 mm (in z) above the metal top of the dipole arms. Two 3D maxima are available near the end of the dipole arms. Assuming the dipole arms are perfectly in one line, the average of these two maxima (in subgrid 2 and subgrid 8) is determined to compensate for any non-parallelity to the measurement plane as well as the sensor displacement. The E-field value stated as calibration value represents the maximum of the interpolated 3D-E-field, in the plane above the dipole surface.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.10.4
Phantom	HAC Test Arch	
Distance Dipole Top - Probe Center	15 mm	
Scan resolution	dx, dy = 5 mm	
Frequency	3500 MHz ± 1 MHz 3900 MHz ± 1 MHz	
Input power drift	< 0.05 dB	

Maximum Field values at 3500 MHz

E-field 15 mm above dipole surface	condition	**Interpolated maximum**
Maximum measured above high end	100 mW input power	83.1 V/m = 38.39 dBV/m
Maximum measured above low end	100 mW input power	82.5 V/m = 38.33 dBV/m
Averaged maximum above arm	100 mW input power	**82.8 V/m ± 12.8 % (k=2)**

Maximum Field values at 3900 MHz

E-field 15 mm above dipole surface	condition	**Interpolated maximum**
Maximum measured above high end	100 mW input power	81.3 V/m = 38.21 dBV/m
Maximum measured above low end	100 mW input power	80.4 V/m = 38.11 dBV/m
Averaged maximum above arm	100 mW input power	**80.9 V/m ± 12.8 % (k=2)**

Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters

Nominal Frequencies

Frequency	Return Loss	Impedance
3300 MHz	18.2 dB	64.0 Ω + 0.0 jΩ
3400 MHz	23.0 dB	54.3 Ω - 6.0 jΩ
3500 MHz	24.2 dB	50.0 Ω - 6.2 jΩ
3600 MHz	21.9 dB	44.8 Ω - 5.5 jΩ
3700 MHz	21.1 dB	42.1 Ω + 1.5 jΩ

Additional Frequencies

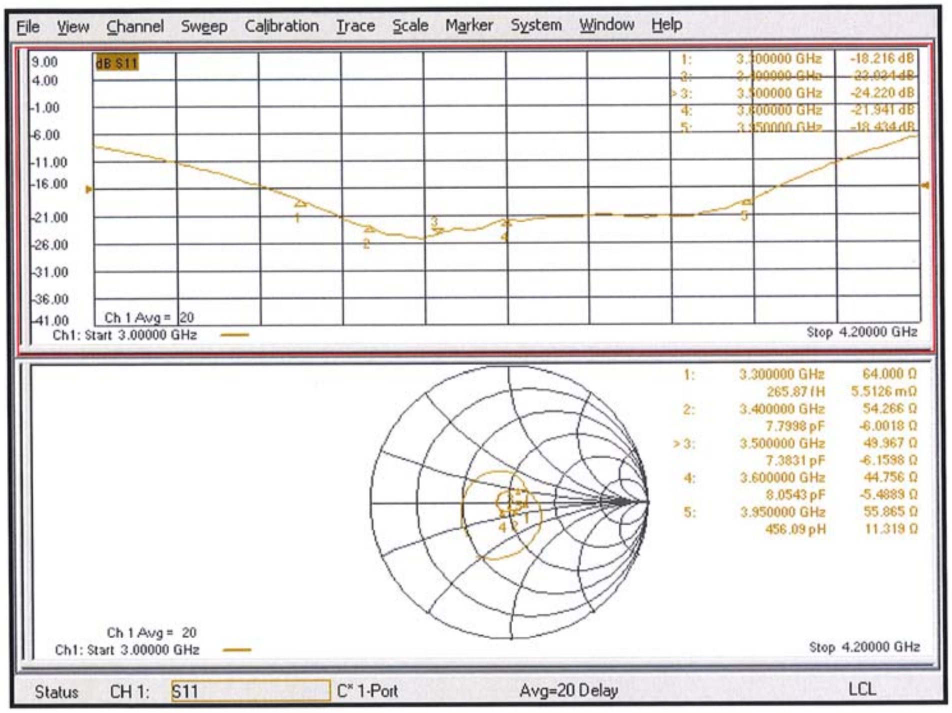
Frequency	Return Loss	Impedance
3900 MHz	20.3 dB	51.2 Ω + 9.7 jΩ

3.2 Antenna Design and Handling

The calibration dipole has a symmetric geometry with a built-in two stub matching network, which leads to the enhanced bandwidth.
The dipole is built of standard semirigid coaxial cable. The internal matching line is open ended. The antenna is therefore open for DC signals.
Do not apply force to dipole arms, as they are liable to bend. The soldered connections near the feedpoint may be damaged. After excessive mechanical stress or overheating, check the impedance characteristics to ensure that the internal matching network is not affected.

After long term use with 40W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

Impedance Measurement Plot



DASY5 E-field Result

Date: 02.03.2021

Test Laboratory: SPEAG Lab2

DUT: HAC Dipole 3500 MHz; Type: CD3500V3; Serial: CD3500V3 - SN: 1015

Communication System: UID 0 - CW ; Frequency: 3500 MHz, Frequency: 3900 MHz
Medium parameters used: $\sigma = 0$ S/m, $\varepsilon_r = 1$; $\rho = 0$ kg/m^3
Phantom section: RF Section
Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EF3DV3 - SN4013; ConvF(1, 1, 1) @ 3500 MHz, ConvF(1, 1, 1) @ 3900 MHz; Calibrated: 28.12.2020
- Sensor-Surface: (Fix Surface)
- Electronics: DAE4 Sn781; Calibrated: 23.12.2020
- Phantom: HAC Test Arch with AMCC; Type: SD HAC P01 BA; Serial: 1070
- DASY52 52.10.4(1527); SEMCAD X 14.6.14(7483)

Dipole E-Field measurement @ 3500MHz/E-Scan - 3500MHz d=15mm/Hearing Aid Compatibility Test (41x121x1):
Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 36.09 V/m; Power Drift = 0.01 dB
Applied MIF = 0.00 dB
RF audio interference level = 38.39 dBV/m
Emission category: M2

MIF scaled E-field

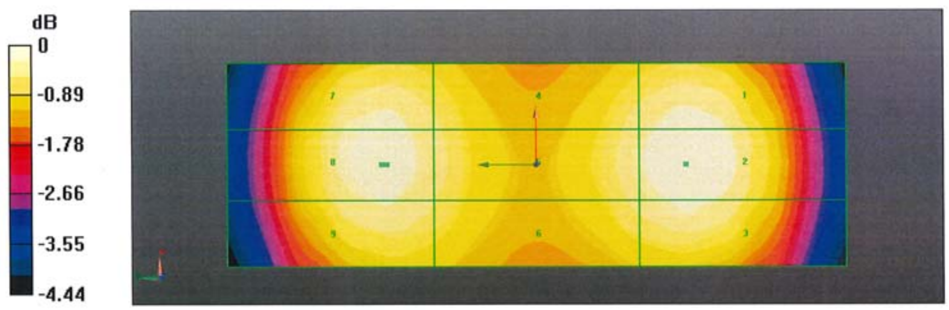
Grid 1 **M2** **38.27 dBV/m**	Grid 2 **M2** **38.39 dBV/m**	Grid 3 **M2** **38.18 dBV/m**
Grid 4 **M2** **37.98 dBV/m**	Grid 5 **M2** **38.08 dBV/m**	Grid 6 **M2** **37.91 dBV/m**
Grid 7 **M2** **38.23 dBV/m**	Grid 8 **M2** **38.33 dBV/m**	Grid 9 **M2** **38.13 dBV/m**

Certificate No: CD3500V3-1015_Mar21 Page 6 of 7

Dipole E-Field measurement @ 3900MHz/E-Scan - 3900MHz d=15mm/Hearing Aid Compatibility Test (41x121x1):
Interpolated grid: dx=0.5000 mm, dy=0.5000 mm
Device Reference Point: 0, 0, -6.3 mm
Reference Value = 32.96 V/m; Power Drift = -0.00 dB
Applied MIF = 0.00 dB
RF audio interference level = 38.21 dBV/m
Emission category: M2

MIF scaled E-field

Grid 1 **M2** **38.08 dBV/m**	Grid 2 **M2** **38.21 dBV/m**	Grid 3 **M2** **38.03 dBV/m**
Grid 4 **M2** **37.86 dBV/m**	Grid 5 **M2** **37.96 dBV/m**	Grid 6 **M2** **37.84 dBV/m**
Grid 7 **M2** **38 dBV/m**	Grid 8 **M2** **38.11 dBV/m**	Grid 9 **M2** **37.92 dBV/m**



0 dB = 83.11 V/m = 38.39 dBV/m

Certificate No: CD3500V3-1015_Mar21 Page 7 of 7

16. CONCLUSION

The measurements indicate that the referenced wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

Please note that the M-rating for this equipment only represents the field interference possible against a hypothetical and typical hearing aid. The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

17. REFERENCES

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